

### FEATURES

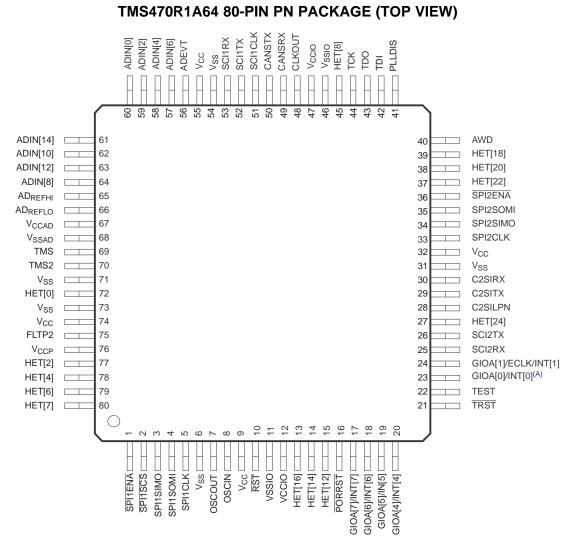
- High-Performance Static CMOS Technology
- TMS470R1x 16/32-Bit RISC Core (ARM7TDMI™)
  - 24-MHz System Clock (48-MHz Pipeline Mode)
  - Independent 16/32-Bit Instruction Set
  - Open Architecture With Third-Party Support
  - Built-In Debug Module
  - Big-Endian Format Utilized
- Integrated Memory
  - 64K-Byte Program Flash
    - One Bank With Five Contiguous Sectors
    - Internal State Machine for Programming and Erase
  - 8K-Byte Static RAM (SRAM)
- Operating Features
  - Core Supply Voltage (V<sub>CC</sub>): 1.71 V-2.06 V
  - I/O Supply Voltage (V<sub>CCIO</sub>): 3.0 V-3.6 V
  - Low-Power Modes: STANDBY and HALT
  - Extended Industrial Temperature Range
- 470+ System Module
  - 32-Bit Address Space Decoding
  - Bus Supervision for Memory and Peripherals
  - Analog Watchdog (AWD) Timer
  - Real-Time Interrupt (RTI)
  - System Integrity and Failure Detection
- Zero-Pin Phase-Locked Loop (ZPLL)-Based Clock Module With Prescaler
  - Multiply-by-4 or -8 Internal ZPLL Option
  - ZPLL Bypass Mode

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- Six Communication Interfaces:
  - Two Serial Peripheral Interfaces (SPIs)
     255 Programmable Baud Rates
  - Two Serial Communication Interfaces (SCIs)
    - 2<sup>24</sup> Selectable Baud Rates
    - Asynchronous/Isosynchronous Modes
  - Standard CAN Controller (SCC)
  - 16-Mailbox Capacity
  - Fully Compliant With CAN Protocol, Version 2.0B
  - Class II Serial Interface (C2SIa)
    - Two Selectable Data Rates
    - Normal Mode 10.4 Kbps and 4X Mode 41.6 Kbps
- High-End Timer (HET)
  - 13 Programmable I/O Channels:
    - 12 High-Resolution Pins
    - 1 Standard-Resolution Pin
  - High-Resolution Share Feature (XOR)
  - HET RAM (64-Instruction Capacity)
- 10-Bit Multi-Buffered ADC (MibADC) 8-Channel
  - 64-Word FIFO Buffer
  - Single- or Continuous-Conversion Modes
  - 1.55  $\mu s$  Minimum Sample and Conversion Time
  - Calibration Mode and Self-Test Features
- 6 External Interrupts
- Flexible Interrupt Handling
- 5 Dedicated General-Purpose I/O (GIO) Pins, 1 Input-Only GIO Pin, and 34 Additional Peripheral I/Os
- External Clock Prescale (ECP) Module
  - Programmable Low-Frequency External Clock (CLK)
- On-Chip Scan-Base Emulation Logic, IEEE Standard 1149.1 (1) (JTAG) Test-Access Port
- 80-Pin Plastic Low-Profile Quad Flatpack (PN Suffix)
- (1) The test-access port is compatible with the IEEE Standard 1149.1-1990, IEEE Standard Test-Access Port and Boundary Scan Architecture specification. Boundary scan is not supported on this device.

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A. GIOA[0]/INT0 (pin 23) is an input-only GIO pin.

### DESCRIPTION

The TMS470R1A64 <sup>(2)</sup> device is a member of the Texas Instruments TMS470R1x family of general-purpose 16/32-bit reduced instruction set computer (RISC) microcontrollers. The A64 microcontroller offers high performance utilizing the high-speed ARM7TDMI 16/32-bit RISC central processing unit (CPU), resulting in a high instruction throughput while maintaining high code efficiency. The ARM7TDMI 16/32-bit RISC CPU views memory as a linear collection of bytes numbered upwards from 0. The TMS470R1A64 utilizes the big-endian format, where the most significant byte of a word is stored at the lowest numbered byte and the least significant byte at the highest numbered byte.

High-end embedded control applications demand more performance from their controllers while maintaining low costs. The A64 RISC core architecture offers solutions to these performance and cost demands while maintaining low power consumption.

The A64 device contains the following:

- ARM7TDMI 16/32-Bit RISC CPU
- TMS470R1x system module (SYS) with 470+ enhancements
- 64K-byte flash
- 8K-byte SRAM

<sup>(2)</sup> Throughout the remainder of this document, the TMS470R1A64 device will be referred to as either the full device name, TMS470R1A64, or as A64.

- Zero-pin phase-locked loop (ZPLL) clock module
- Analog watchdog (AWD) timer
- Real-time interrupt (RTI) module
- Two serial peripheral interface (SPI) modules
- Two serial communication interface (SCI) modules
- Standard CAN controller (SCC)
- Class II serial interface (C2SIa)
- 10-bit multi-buffered analog-to-digital converter (MibADC), 8-input channels
- High-end timer (HET) controlling 13 I/Os
- External Clock Prescale (ECP)
- Up to 39 I/O pins and 1 input-only pin

The functions performed by the 470+ system module (SYS) include:

- Address decoding
- Memory protection
- Memory and peripherals bus supervision
- Reset and abort exception management
- Prioritization for all internal interrupt sources
- Device clock control
- Parallel signature analysis (PSA)

This data sheet includes device-specific information such as memory and peripheral select assignment, interrupt priority, and a device memory map. For a more detailed functional description of the SYS module, see the *TMS470R1x System Module Reference Guide* (literature number SPNU189).

The A64 memory includes general-purpose SRAM supporting single-cycle read/write accesses in byte, half-word, and word modes.

The flash memory on the A64 device is a nonvolatile, electrically erasable and programmable memory implemented with a 32-bit-wide data bus interface. The flash operates with a system clock frequency of up to 24 MHz. In pipeline mode, the flash operates with a system clock frequency of up to 48 MHz. For more detailed information on the flash, see the *F05 flash* section of this data sheet and the *TMS470R1x F05 Flash Reference Guide* (literature number SPNU213).

The A64 device has six communication interfaces: two SPIs, two SCIs, an SCC, and a C2SIa. The SPI provides a convenient method of serial interaction for high-speed communications between similar shift-register type devices. The SCI is a full-duplex, serial I/O interface intended for asynchronous communication between the CPU and other peripherals using the standard non-return-to-zero (NRZ) format. The SCC uses a serial, multimaster communication protocol that efficiently supports distributed real-time control with robust communication rates of up to 1 megabit per second (Mbps). The SCC is ideal for applications operating in noisy and harsh environments (e.g., industrial fields) that require reliable serial communication or multiplexed wiring. The C2SIa allows the A64 to transmit and receive messages on a class II network following an SAE J1850 <sup>(3)</sup> standard.

For more detailed functional information on the SPI, SCI, and SCC peripherals, see the specific TMS470R1x peripheral reference guides (literature numbers SPNU195, SPNU196, and SPNU197, respectively). For more detailed functional information on the C2SIa peripheral, see the *TMS470R1x Class II Serial Interface A (C2SIa) Reference Guide* (literature number SPNU218).

The HET is an advanced intelligent timer that provides sophisticated timing functions for real-time applications. The timer is software-controlled, using a reduced instruction set, with a specialized timer micromachine and an attached I/O port. The HET can be used for compare, capture, or general-purpose I/O. It is especially well suited for applications requiring multiple sensor information and drive actuators with complex and accurate time pulses. For more detailed functional information on the HET, see the *TMS470R1x High-End Timer (HET) Reference Guide* (literature number SPNU199).

<sup>(3)</sup> SAE Standard J1850 Class B Data Communication Network Interface.

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The A64 HET peripheral contains the XOR-share feature. This feature allows two adjacent HET high-resolution channels to be XORed together, making it possible to output smaller pulses than a standard HET. For more detailed information on the HET XOR-share feature, see the *TMS470R1x High-End Timer (HET)* Reference *Guide* (literature number SPNU199).

The A64 device has a 10-bit-resolution sample-and-hold MibADC. The MibADC channels can be converted individually or can be grouped by software for sequential conversion sequences. There are three separate groupings, two of which are triggerable by an external event. Each sequence can be converted once when triggered or configured for continuous conversion mode. For more detailed functional information on the MibADC, see the *TMS470R1x Multi-Buffered Analog-to-Digital Converter (MibADC) Reference Guide* (literature number SPNU206).

The zero-pin phase-locked loop (ZPLL) clock module contains a phase-locked loop, a clock-monitor circuit, a clock-enable circuit, and a prescaler (with prescale values of 1–8). The function of the ZPLL is to multiply the external frequency reference to a higher frequency for internal use. The ZPLL provides ACLK to the system (SYS) module. The SYS module subsequently provides the system clock (SYSCLK), real-time interrupt clock (RTICLK), CPU clock (MCLK), and peripheral interface clock (ICLK) to all other A64 device modules. For more detailed functional information on the ZPLL, see the *TMS470R1x Zero-Pin Phase-Locked Loop (ZPLL) Clock Module Reference Guide* (literature number SPNU212).

#### NOTE:

ACLK should not be confused with the MibADC internal clock, ADCLK. ACLK is the continuous system clock from an external resonator/crystal reference.

The A64 device also has an external clock prescaler (ECP) module that, when enabled, outputs a continuous external clock (ECLK) on a specified GIO pin. The ECLK frequency is a user-programmable ratio of the peripheral interface clock (ICLK) frequency. For more detailed functional information on the ECP, see the *TMS470R1x External Clock Prescaler (ECP) Reference Guide* (literature number SPNU202).



### **Device Characteristics**

The TMS470R1A64 device is a derivative of the F05 system emulation device SE470R1VB8AD. Table 1 identifies all the characteristics of the TMS470R1A64 device except the SYSTEM and CPU, which are generic.

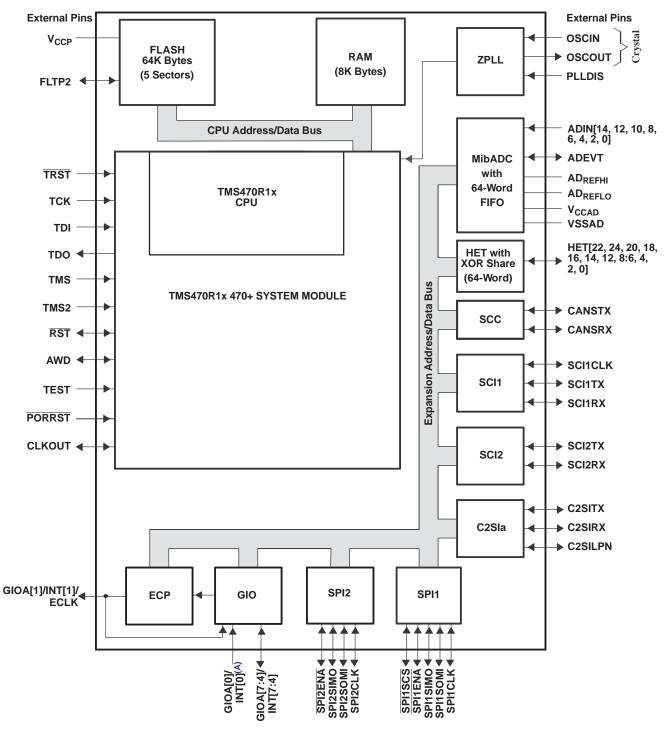
|                              |                                   | Device Characteristics  |  |  |  |  |
|------------------------------|-----------------------------------|---|--|--|--|--|
| CHARACTERISTICS              | DEVICE DESCRIPTION                | COMMENTS  |  |  |  |  |
|                              |                                   | MEMORY  |  |  |  |  |
| For the number of memory sel | lects on this device, see the "M  | lemory Selection Assignment" table (Table 3).   |  |  |  |  |
|                              |                                   | Flash is pipeline-capable.  |  |  |  |  |
| INTERNAL MEMORY              | 64K-Byte flash<br>8K-Byte SRAM    | The A64 RAM is implemented in one 8K-byte array selected by two memory-select signals (see the "Memory Selection Assignment" table, Table 3).   |  |  |  |  |
|                              |                                   | PERIPHERALS   |  |  |  |  |
|                              |                                   | e "Interrupt Priority" table (Table 6). For the 1K-byte peripheral address<br>, System Module, and Flash Base Addresses" table (Table 5).   |  |  |  |  |
| CLOCK                        | ZPLL                              | Zero-pin PLL has no external loop filter pins.  |  |  |  |  |
| GENERAL-PURPOSE I/Os         | 5 I/O<br>1 Input only             | Port A has 6 external pins—GIOA[2]/INT2 and GIOA[3]/INT3 are not available.   |  |  |  |  |
| ECP                          | YES                               |   |  |  |  |  |
| C2SIa                        | 1                                 |   |  |  |  |  |
| SCI                          | 1 (3-pin)<br>1 (2-pin)            | SCI2 has no external clock pin, only transmit/receive pins (SCI2TX and SCI2RX)  |  |  |  |  |
| CAN (HECC and/or SCC)        | 1 SCC                             | Standard CAN controller   |  |  |  |  |
| SPI (5-pin, 4-pin or 3-pin)  | 1 (5-pin)<br>1 (4-pin)            | SPI2 has no chip select pin.  |  |  |  |  |
|                              |                                   | The A64 device has both the logic and registers for a full 32-I/O HET implemented, even though not all 32 pins are available externally.  |  |  |  |  |
| HET with XOR Share           | 13 I/O                            | The high-resolution (HR) SHARE feature allows even-numbered HR pins to<br>share the next higher odd-numbered HR pin structures. This HR sharing is<br>independent of whether or not the odd pin is available externally. If an odd<br>pin is available externally and shared, then the odd pin can only be used as<br>a general-purpose I/O. For more information on HR SHARE, see the<br><i>TMS470R1x High-End Timer (HET) Reference Guide</i> (literature number<br>SPNU199). |  |  |  |  |
| HET RAM                      | 64-Instruction Capacity           |   |  |  |  |  |
| MibADC                       | 10-bit, 8-channel<br>64-word FIFO | 8-channel MibADC. Both the logic and registers for a full 16-channel MibADC are present.  |  |  |  |  |
| CORE VOLTAGE                 | 1.71–2.06 V                       |   |  |  |  |  |
| I/O VOLTAGE                  | 3.0–3.6 V                         |   |  |  |  |  |
| PINS                         | 80                                |   |  |  |  |  |
| PACKAGE                      | PN                                |   |  |  |  |  |
|                              |                                   |   |  |  |  |  |

### **Table 1. Device Characteristics**

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**Functional Block Diagram** 



GIOA[0]/INT[0] is an input-only GIO pin. Α.

#### **Table 2. Terminal Functions**

| TERM                    | INAL          |                        | INTERNAL                           | DESCRIPTION  |  |  |  |  |
|-------------------------|---------------|------------------------|------------------------------------|--|--|--|--|--|
| NAME                    | PIN<br>NUMBER | TYPE <sup>(1)(2)</sup> | PULLUP/<br>PULLDOWN <sup>(3)</sup> |  |  |  |  |  |
|                         |               | -                      | HIGH                               | I-END TIMER (HET)  |  |  |  |  |
| HET[0]                  | 72            |                        |                                    |  |  |  |  |  |
| HET[2]                  | 77            |                        |                                    | The A64 douise has both the logic and registers for a full 22 1/O HET  |  |  |  |  |
| HET[4]                  | 78            |                        |                                    | The A64 device has both the logic and registers for a full 32-I/O HET implemented, even though not all 32 pins are available externally                    |  |  |  |  |
| HET[6]                  | 79            |                        |                                    | Timer input capture or output compare. The HET[31:0] applicable pins can   |  |  |  |  |
| HET[7]                  | 80            |                        |                                    | be programmed as general-purpose input/output (GIO) pins.  |  |  |  |  |
| HET[8]                  | 45            |                        |                                    | HET pins [22, 20, 18, 16, 14, 12, 8, 7, 6, 4, 2, and 0] are high-resolution pins for A64. HET[24] is a standard-resolution pin.                            |  |  |  |  |
| HET[12]                 | 15            | 3.3-V I/O              | IPD (20 μA)                        | The high-resolution (HR) SHARE feature allows even-numbered HR pins to   |  |  |  |  |
| HET[14]                 | 14            |                        |                                    | share the next higher odd-numbered HR pin structures. This HR sharing is   |  |  |  |  |
| HET[16]                 | 13            |                        |                                    | independent of whether or not the odd-numbered pin is available externally.<br>If an odd-numbered pin is available externally and shared, then the odd pin |  |  |  |  |
| HET[18]                 | 39            |                        |                                    | can only be used as a general-purpose I/O. For more information on HR  |  |  |  |  |
| HET[20]                 | 38            |                        |                                    | SHARE, see the <i>TMS470R1x High-End Timer Reference Guide</i> (literature number SPNU199).  |  |  |  |  |
| HET[22]                 | 37            |                        |                                    | number SPNU199).   |  |  |  |  |
| HET[24]                 | 27            |                        |                                    |  |  |  |  |  |
|                         |               |                        | STANDARD                           | CAN CONTROLLER (SCC)   |  |  |  |  |
| CANSRX                  | 49            | 3.3-V I/O              |                                    | SCC receive pin or GIO pin   |  |  |  |  |
| CANSTX                  | 50            | 3.3-V I/O              | IPU (20 μA)                        | SCC transmit pin or GIO pin  |  |  |  |  |
|                         |               |                        | CLASS II SE                        | RIAL INTERFACE (C2SIA)   |  |  |  |  |
| C2SILPN                 | 28            | 3.3-V I/O              | IPD (20 μA)                        | C2SIa module loopback enable pin or GIO pin  |  |  |  |  |
| C2SIRX                  | 30            | 3.3-V I/O              |                                    | C2SIa module receive data input pin or GIO pin   |  |  |  |  |
| C2SITX                  | 29            | 3.3-V I/O              | IPD (20 μA)                        | C2SIa module transmit data output pin or GIO pin   |  |  |  |  |
|                         |               |                        | GENERA                             | AL-PURPOSE I/O (GIO)   |  |  |  |  |
| GIOA[0]/INT[0]          | 23            | 3.3-V I                |                                    |  |  |  |  |  |
| GIOA[1]/INT[1]<br>/ECLK | 24            |                        |                                    | General-purpose input/output pins. GIOA[0]/INT[0] is an input-only pin. GIOA[7:0]/INT[7:0] are interrupt-capable pins.                                     |  |  |  |  |
| GIOA[4]/INT[4]          | 20            |                        | IPD (20 μA)                        | The GIOA[1]/INT[1]/ECLK pin is multiplexed with the external clock-out   |  |  |  |  |
| GIOA[5]/INT[5]          | 19            | 3.3-V I/O              |                                    | function of the external clock prescale (ECP) module.<br>GIOA[2]/INT[2] and GIOA[3]/INT[3]] pins are not applicable on the A64                             |  |  |  |  |
| GIOA[6]/INT[6]          | 18            |                        |                                    | device.  |  |  |  |  |
| GIOA[7]/INT[7]          | 17            |                        |                                    |  |  |  |  |  |
|                         |               | MULTI-B                | UFFERED ANAL                       | DG-TO-DIGITAL CONVERTER (MibADC)   |  |  |  |  |
| ADEVT                   | 56            | 3.3-V I/O              |                                    | MibADC event input. ADEVT can be programmed as a GIO pin.  |  |  |  |  |
| ADIN[0]                 | 60            |                        |                                    | MibADC analog input pins   |  |  |  |  |
| ADIN[2]                 | 59            |                        |                                    | The A64 device has only 8 input channels but all S/W registers are   |  |  |  |  |
| ADIN[4]                 | 58            |                        |                                    | capable. ADIN[15,13, 11, 9, 7, 5, 3, and 1] pins are not applicable to the A64 device.   |  |  |  |  |
| ADIN[6]                 | 57            | 221/1                  | IPD (20 μA)                        |  |  |  |  |  |
| ADIN[8]                 | 64            | - 3.3-V I              |                                    |  |  |  |  |  |
| ADIN[10]                | 62            |                        |                                    |  |  |  |  |  |
| ADIN[12]                | 63            |                        |                                    |  |  |  |  |  |
| ADIN[14]                | 61            | 1                      |                                    |  |  |  |  |  |
| AD <sub>REFHI</sub>     | 65            | 3.3-V<br>REF I         |                                    | MibADC module high-voltage reference input   |  |  |  |  |
| AD <sub>REFLO</sub>     | 66            | GND<br>REF I           |                                    | MibADC module low-voltage reference input  |  |  |  |  |

(1) I = input, O = output, PWR = power, GND = ground, REF = reference voltage, NC = no connect
 (2) All I/O pins, except RST, are configured as inputs while PORRST is low and immediately after PORRST goes high.

IPD = internal pulldown, IPU = internal pullup (all internal pullups and pulldowns are active on input pins, independent of the PORRST (3) state.)

| Table 2. Terminal F | unctions (continued) |
|---------------------|----------------------|
|---------------------|----------------------|

| TER               | MINAL  | TYPE <sup>(1)(2)</sup> | INTERNAL                           |   |  |  |  |
|-------------------|--------|------------------------|------------------------------------|---|--|--|--|
| NAME              | NUMBER |                        | PULLUP/<br>PULLDOWN <sup>(3)</sup> | DESCRIPTION   |  |  |  |
| V <sub>CCAD</sub> | 67     | 3.3-V<br>PWR           |                                    | MibADC analog supply voltage  |  |  |  |
| V <sub>SSAD</sub> | 68     | GND                    |                                    | MibADC analog ground reference  |  |  |  |
|                   |        | -                      | SERIAL PERIP                       | HERAL INTERFACE 1 (SPI1)  |  |  |  |
| SPI1CLK           | 5      |                        |                                    | SPI1 clock. SPI1CLK can be programmed as a GIO pin.   |  |  |  |
| SPI1ENA           | 1      |                        |                                    | SPI1 chip enable. SPI1ENA can be programmed as a GIO pin.   |  |  |  |
| SPI1SCS           | 2      |                        |                                    | SPI1 slave chip select. SPI1SCS can be programmed as a GIO pin.   |  |  |  |
| SPI1SIMO          | 3      | 3.3-V I/O              | IPD (20 μA)                        | SPI1 data stream. Slave in/master out. SPI1SIMO can be programmed as a GIO pin.   |  |  |  |
| SPI1SOMI          | 4      |                        |                                    | SPI1 data stream. Slave out/master in. SPI1SOMI can be programmed as a GIO pin.   |  |  |  |
|                   |        |                        | SERIAL PERIP                       | HERAL INTERFACE 2 (SPI2)  |  |  |  |
| SPI2CLK           | 33     |                        |                                    | SPI2 clock. SPI2CLK can be programmed as a GIO pin.   |  |  |  |
| SPI2ENA           | 36     | 1                      |                                    | SPI2 chip enable. SPI2ENA can be programmed as a GIO pin.   |  |  |  |
| SPI2SIMO          | 34     | 3.3-V I/O              | IPD (20 μA)                        | SPI2 data stream. Slave in/master out. SPI2SIMO can be programmed as a GIO pin.   |  |  |  |
| SPI2SOMI          | 35     |                        |                                    | SPI2 data stream. Slave out/master in. SPI2SOMI can be programmed as a GIO pin.   |  |  |  |
|                   |        |                        | ZERO-PIN PH                        | ASE-LOCKED LOOP (ZPLL)  |  |  |  |
| OSCIN             | 8      | 1.8-V I                |                                    | Crystal connection pin or external clock input  |  |  |  |
| OSCOUT            | 7      | 1.8-V O                |                                    | External crystal connection pin   |  |  |  |
| PLLDIS            | 41     | 3.3-V I                | IPD (20 μA)                        | Enable/disable the ZPLL. The ZPLL can be bypassed and the oscillator becomes the system clock. If not in bypass mode, TI recommends that PLLDIS be connected to ground or pulled down to ground by an external resistor.  |  |  |  |
|                   |        | 5                      | SERIAL COMMUN                      | IICATIONS INTERFACE 1 (SCI1)  |  |  |  |
| SCI1CLK           | 51     | 3.3-V I/O              | IPD (20 μA)                        | SCI1 clock. SCI1CLK can be programmed as a GIO pin.   |  |  |  |
| SCI1RX            | 53     | 3.3-V I/O              | IPU (20 μA)                        | SCI1 data receive. SCI1RX can be programmed as a GIO pin.   |  |  |  |
| SCI1TX            | 52     | 3.3-V I/O              | IPU (20 μA)                        | SCI1 data transmit. SCI1TX can be programmed as a GIO pin.  |  |  |  |
|                   |        |                        | SERIAL COMMUN                      | IICATIONS INTERFACE 2 (SCI2)  |  |  |  |
| SCI2RX            | 25     | 3.3-V I/O              | IPU (20 μA)                        | SCI2 data receive. SCI2RX can be programmed as a GIO pin.   |  |  |  |
| SCI2TX            | 26     | 3.3-V I/O              | IPU (20 μA)                        | SCI2 data transmit. SCI2TX can be programmed as a GIO pin.  |  |  |  |
|                   |        | -                      | SYST                               | EM MODULE (SYS)   |  |  |  |
| CLKOUT            | 48     | 3.3-V I/O              | IPD (20 μA)                        | Bidirectional pin. CLKOUT can be programmed as a GIO pin or the output of SYSCLK, ICLK, or MCLK.  |  |  |  |
| PORRST            | 16     | 3.3-V I                | IPD (20 μA)                        | Input master chip power-up reset. External V <sub>CC</sub> monitor circuitry must assert a power-on reset.  |  |  |  |
| RST               |        |                        |                                    | Bidirectional reset. The internal circuitry can assert a reset, and an external system reset can assert a device reset.   |  |  |  |
|                   | 10     | 3.3-V I/O              | IPU (20 μA)                        | On RST, the output buffer is implemented as an open drain (drives low only. To ensure an external reset is not arbitrarily generated, TI recommends that an external pullup resistor be connected to RST.   |  |  |  |
|                   |        | 1                      | WATCHDOG/RE                        | AL-TIME INTERRUPT (WD/RTI)  |  |  |  |
| AWD               | 40     | 3.3-V I/O              | IPD (20 μA)                        | Analog watchdog reset. The AWD pin provides a system reset if the WD KEY is not written in time by the system, providing an external RC network circuit is connected. If the user is not using AWD, TI recommends that AWD be connected to ground or pulled down to ground by an external resistor. |  |  |  |
|                   |        |                        |                                    | For more details on the external RC network circuit, see the <i>TMS470R1x</i> System Module Reference Guide(literature number SPNU189) and the application note Analog Watchdog Resistor, Capacitor and Discharge Interval Selection Constraints (literature number SPNA005).                       |  |  |  |

### Table 2. Terminal Functions (continued)

| TE                | RMINAL        |                        | INTERNAL  |   |  |  |
|-------------------|---------------|------------------------|---|---|--|--|
| NAME              | PIN<br>NUMBER | TYPE <sup>(1)(2)</sup> | PULLUP/<br>PULLDOWN <sup>(3)</sup>  | DESCRIPTION   |  |  |
|                   |               |                        | TE  | ST/DEBUG (T/D)  |  |  |
| тск               | 44            | 3.3-V I                | IPD (20 μA)   | Test clock. TCK controls the test hardware (JTAG)   |  |  |
| TDI               | 42            | 3.3-V I                | IPU (20 μA)   | Test data in. TDI inputs serial data to the test instruction register, test data register, and programmable test address (JTAG).                              |  |  |
| TDO               | 43            | 3.3-V O                | IPD (20 μA)   | Test data out. TDO outputs serial data from the test instruction register, test data register, identification register, and programmable test address (JTAG). |  |  |
| TEST              | 22            | 3.3-V I                | IPD (20 μA)   | Test enable. Reserved for internal use only. TI recommends that TEST be connected to ground or pulled down to ground by an external resistor.                 |  |  |
| TMS               | 69            | 3.3-V I                | IPU (20 μA)   | Serial input for controlling the state of the CPU test access port (TAP) controller (JTAG)  |  |  |
| TMS2              | 70            | 3.3-V I                | IPU (20 μA)   | Serial input for controlling the second TAP. TI recommends that TMS2 be connected to VCCIO or pulled up to VCCIO by an external resistor.                     |  |  |
| TRST              | 21            | 3.3-V I                | IPD (20 μA) Test hardware reset to TAP1 and TAP2. IEEE Standard 1149-1 (JTAG<br>Boundary-Scan Logic. TI recommends that TRST be pulled down to gr<br>by an external resistor. |   |  |  |
|                   |               |                        |   | FLASH   |  |  |
| FLTP2             | 75            | NC                     | Flash test pad 2. For proper operation, FLTP2 must not be connecte connect [NC]).   |   |  |  |
| V <sub>CCP</sub>  | 76            | 3.3-V<br>PWR           | Flash external pump voltage (3.3 V)   |   |  |  |
|                   |               |                        | SUPPLY  | VOLTAGE CORE (1.8 V)  |  |  |
|                   | 9             |                        |   |   |  |  |
| V                 | 32            | 1.8-V                  |   |   |  |  |
| V <sub>CC</sub>   | 55            | PWR                    |   | Core logic supply voltage   |  |  |
|                   | 74            |                        |   |   |  |  |
|                   |               |                        | SUPPLY VO   | LTAGE DIGITAL I/O (3.3 V)   |  |  |
| N/                | 12            | 3.3-V                  |   |   |  |  |
| V <sub>CCIO</sub> | 47            | PWR                    |   | Digital I/O supply voltage  |  |  |
|                   |               |                        | SUPP  | LY GROUND CORE  |  |  |
|                   | 6             |                        |   |   |  |  |
|                   | 31            | 1                      |   |   |  |  |
| V <sub>SS</sub>   | 54            | GND                    |   | Core supply ground reference  |  |  |
|                   | 71            | 1                      |   |   |  |  |
|                   | 73            |                        |   |   |  |  |
|                   | 1             | 1                      | SUPPLY  | GROUND DIGITAL I/O  |  |  |
| V                 | 11            |                        |   |   |  |  |
| V <sub>SSIO</sub> | 46            | GND                    |   | Digital I/O supply ground reference   |  |  |



### A64 Device-Specific Information

#### Memory

Figure 1 shows the memory map of the A64 device.

|                            |                                 |                       |                       | 0xFFFF_FFF                 |
|----------------------------|---------------------------------|-----------------------|-----------------------|----------------------------|
| 0xFFFF_FFFF                | Memory (4G Bytes)               | <sup>-</sup>          | SYSTEM                |                            |
| UXFFFF_FFF                 | System Module Control Registers |                       |                       | 0xFFFF_FD00                |
|                            | (512K Bytes)                    |                       | Reserved              | 0xFFF8_0000                |
| 0xFFF8_0000                |                                 | -                     | HET                   | 1                          |
| 0xFFF7_FFFF                | Peripheral Control Registers    |                       |                       | 0xFFF7_FC00                |
| 0xFFF0_0000                | (512K Bytes)                    |                       | SPI1                  | 0xFFF7_F800                |
| 0xFFEF_FFFF                | Reserved                        |                       | SCI2                  | 0xFFF7_F500                |
| 0xFFE8_C000<br>0xFFE8_BFFF |                                 | - \                   | SCI1                  | 0xFFF7_F400                |
| 0xFFE8_8000<br>0xFFE8_7FFF | Flash Control Registers         |                       | MibADC                | 0xFFF7_F000                |
| 0xFFE8_4024                | Reserved                        |                       | GIO/ECP               | 0xFFF7 EC00                |
| 0xFFE8_4023                | MPU Control Registers           |                       | Reserved              | 1 -                        |
| 0xFFE8_4000<br>0xFFE8_3FFF |                                 |                       | SCC                   | 0xFFF7_E400                |
|                            | Reserved                        |                       |                       | 0xFFF7_E000                |
| 0xFFE0_0000                |                                 |                       | SCC RAM               | 0xFFF7_DC00                |
|                            |                                 | Ň                     | Reserved              | 0xFFF7_D800                |
|                            |                                 |                       | SPI2                  | 0xFFF7D400                 |
|                            |                                 |                       | Reserved              | 0xFFF7 CC00                |
|                            |                                 | RAM<br>(8K Bytes)     | C2SIa                 | 0xFFF7_C800                |
|                            | Program                         |                       | Reserved              | 0xFFF0_0000                |
|                            | and<br>Data Area                | FLASH<br>(64K Bytes)  |                       | <b>_</b> 0X1110_0000       |
|                            | Dala Alea                       | 5 Sectors             |                       | - 0000                     |
|                            |                                 |                       | FIQ                   | 0x0000_001F<br>0x0000_001C |
|                            |                                 | HET RAM<br>(1K Bytes) | IRQ                   | 0x0000_0018                |
|                            |                                 |                       | Reserved              | 0x0000_0014                |
|                            |                                 |                       | Data Abort            | 0x0000_0010                |
|                            |                                 |                       | Prefetch Abort        | 0x0000_000C                |
| 0x0000_0020                |                                 | /                     | Software Interrupt    | 0x0000_0008                |
| 0x0000_001F                | Exception, Interrupt, and       |                       | Undefined Instruction | <br>0x0000_0004            |
| 0x0000_0000                | Reset Vectors                   |                       | Reset                 |                            |
|                            |                                 |                       |                       | 0x0000_0000                |

A. Memory addresses are configurable by the system (SYS) module within the range of 0x0000\_0000 to 0xFFE0\_0000.

B. The CPU registers are not part of the memory map.

Figure 1. Memory Map

#### Memory Selects

Memory selects allow the user to address memory arrays (i.e., flash, RAM, and HET RAM) at user-defined addresses. Each memory select has its own set (low and high) of memory base address registers (MFBAHRx and MFBALRx) that, together, define the array's starting (base) address, block size, and protection.

The base address of each memory select is configurable to any memory address boundary that is a multiple of the decoded block size. The decoded block size for the flash is 0x00100000. For more information on how to control and configure these memory select registers, see the bus structure and memory sections of the *TMS470R1x System Module Reference Guide* (literature number SPNU189).

For the memory selection assignments and the memory selected, see Table 3.

| MEMORY<br>SELECT | MEMORY SELECTED<br>(ALL INTERNAL) | MEMORY<br>SIZE    | MPU | MEMORY BASE<br>ADDRESS REGISTER | STATIC MEM<br>CTL REGISTER |
|------------------|-----------------------------------|-------------------|-----|---------------------------------|----------------------------|
| 0 (fine)         | FLASH                             | C 4 K             | NO  | MFBAHR0 and MFBALR0             |                            |
| 1 (fine)         | FLASH                             | 64K               | NO  | MFBAHR1 and MFBALR1             |                            |
| 2 (fine)         | RAM                               | 8K <sup>(1)</sup> | YES | MFBAHR2 and MFBALR2             |                            |
| 3 (fine)         | RAM                               | 86(1)             | YES | MFBAHR3 and MFBALR3             |                            |
| 4 (fine)         | HET RAM                           | 1K                |     | MFBAHR4 and MFBALR4             | SMCR1                      |

Table 3. Memory Selection Assignment

(1) The starting addresses for both RAM memory-select signals **cannot** be offset from each other by a multiple of the user-defined block size in the memory-base address register.

#### RAM

The A64 device contains 8K bytes of internal static RAM configurable by the SYS module to be addressed within the range of 0x0000\_0000 to 0xFFE0\_0000. This A64 RAM is implemented in one 8K array selected by two memory-select signals. This A64 configuration imposes an additional constraint on the memory map for RAM; the starting addresses for both RAM memory selects cannot be offset from each other by the multiples of the size of the physical RAM (i.e., 8K for the A64 device). The A64 RAM is addressed through memory selects 2 and 3.

The RAM can be protected by the memory protection unit (MPU) portion of the SYS module, allowing the user finer blocks of memory protection than is allowed by the memory selects. The MPU is ideal for protecting an operating system while allowing access to the current task. For more detailed information on the MPU portion of the SYS module and memory protection, see the memory section of the *TMS470R1x System Module Reference Guide* (literature number SPNU189).

#### F05 flash

The F05 flash memory is a nonvolatile electrically erasable and programmable memory implemented with a 32-bit-wide data bus interface. The F05 flash has an external state machine for programming and erase functions. See the *flash read* and *flash program and erase* sections below.

#### NOTE:

Flash must be mapped to a boundary of zero or a multiple of 0x00100000. RAM cannot be mapped into the same 0x00100000 space.

#### flash protection keys

The A64 devices provide flash protection keys. These four 32-bit protection keys prevent program/erase/compaction operations from occurring until after the four protection keys have been matched by the CPU loading the correct user keys into the FMPKEY control register. The protection keys on the A64 are located in the last 4 words of the first 8K sector. For more detailed information on the flash protection keys and the FMPKEY control register, see the protection keys portions of the *TMS470R1x F05 Flash Reference Guide* (literature number SPNU213).

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#### flash read

The A64 flash memory is configurable by the SYS module to be addressed within the range of 0x0000\_0000 to 0xFFE0\_0000. The flash is addressed through memory selects 0 and 1.

#### NOTE:

The flash external pump voltage (VCCP) is required for all operations (program, erase, and read).

#### flash pipeline mode

When in pipeline mode, the flash operates with a system clock frequency of up to 48 MHz. When in normal mode, the flash operates with a system clock frequency of up to 24 MHz). Flash in pipeline mode is capable of accessing 64-bit words and provides two 32-bit pipelined words to the CPU. Also in pipeline mode, the flash can be read with no wait states when memory addresses are contiguous (after the initial 1-or 2-wait-state reads).

#### NOTE:

After a system reset, pipeline mode is **disabled** (the ENPIPE bit FMREGOPT[0] = 0). In other words, the A64 device powers up and comes out of reset in non-pipeline mode. Furthermore, setting the flash configuration mode bit (GLBCTRL[4]) will override pipeline mode.

#### flash program and erase

The A64 device flash has one 64K-byte bank that consists of five sectors. These five sectors are shown in Table 4.

| SECTOR NO. | SEGMENT   | LOW ADDRESS | HIGH ADDRESS |
|------------|-----------|-------------|--------------|
| 0          | 8K Bytes  | 0x0000_0000 | 0x0000_1FFF  |
| 1          | 8K Bytes  | 0x0000_2000 | 0x0000_3FFF  |
| 2          | 16K Bytes | 0x0000_4000 | 0x0000_7FFF  |
| 3          | 16K Bytes | 0x0000_8000 | 0x0000_BFFF  |
| 4          | 16K Bytes | 0x0000_C000 | 0x0000_FFFF  |

#### **Table 4. Flash Sectors**

The minimum size for an erase operation is one sector. The maximum size for a program operation is one 16-bit word.

#### NOTE:

The flash external pump voltage ( $V_{CCP}$ ) is required for all operations (program, erase, and read).

Execution can occur from one bank while programming/erasing any or all sectors of another bank. However, execution cannot occur from any sector within a bank that is being programmed or erased.

#### NOTE:

When the OTP sector is enabled, the rest of the flash memory is disabled. The OTP memory can only be read or programmed from code executed out of RAM.

For more detailed information on flash program and erase operations, see the *TMS470R1x F05 Flash Reference Guide* (literature number SPNU213).

### HET RAM

The A64 device contains HET RAM. The HET RAM has a 64-instruction capability. The HET RAM is configurable by the SYS module to be addressed within the range of 0x0000\_0000 to 0xFFE0\_0000. The HET RAM is addressed through memory select 4.

#### **Peripheral Selects and Base Addresses**

The A64 device uses 10 of the 16 peripheral selects to decode the base addresses of the peripherals. These peripheral selects are fixed and transparent to the user since they are part of the decoding scheme used by the SYS module.

Control registers for the peripherals, SYS module, and flash begin at the base addresses shown in Table 5.

|                         | ADDRES       | S RANGE        |                    |  |  |
|-------------------------|--------------|----------------|--------------------|--|--|
| CONNECTING MODULE       | BASE ADDRESS | ENDING ADDRESS | PERIPHERAL SELECTS |  |  |
| SYSTEM                  | 0xFFFF_FD00  | 0xFFFF_FFF     | N/A                |  |  |
| RESERVED                | 0xFFF8_0000  | 0xFFFF_FCFF    | N/A                |  |  |
| HET                     | 0xFFF7_FC00  | 0xFFF7_FFFF    | PS[0]              |  |  |
| SPI1                    | 0xFFF7_F800  | 0xFFF7_FBFF    | PS[1]              |  |  |
| SCI2                    | 0XFFF7_F500  | 0XFFF7_F7FF    | DC(2)              |  |  |
| SCI1                    | 0xFFF7_F400  | 0xFFF7_F4FF    | PS[2]              |  |  |
| ADC                     | 0xFFF7_F000  | 0xFFF7_F3FF    | PS[3]              |  |  |
| GIO/ECP                 | 0xFFF7_EC00  | 0xFFF7_EFFF    | PS[4]              |  |  |
| Reserved                | 0xFFF7_E400  | 0xFFF7_EBFF    | PS[5]–PS[6]        |  |  |
| SCC                     | 0xFFF7_E000  | 0xFFF7_E3FF    | PS[7]              |  |  |
| SCC RAM                 | 0xFFF7_DC00  | 0xFFF7_DFFF    | PS[8]              |  |  |
| Reserved                | 0XFFF7_D800  | 0XFFF7_DBFF    | PS[9]              |  |  |
| SPI2                    | 0XFFF7_D400  | 0XFFF7_D7FF    | PS[10]             |  |  |
| Reserved                | 0xFFF7_CC00  | 0xFFF7_D3FF    | PS[11]–PS[12]      |  |  |
| C2SIa                   | 0xFFF7_C800  | 0xFFF7_CBFF    | PS[13]             |  |  |
| Reserved                | 0xFFF7_C000  | 0xFFF7_C7FF    | PS[14]–PS[15]      |  |  |
| Reserved                | 0xFFF0_0000  | 0xFFF7_BFFF    | N/A                |  |  |
| Flash control registers | 0xFFE8_8000  | 0xFFE8_BFFF    | N/A                |  |  |
| MPU control registers   | 0xFFE8_4000  | 0xFFE8_4023    | N/A                |  |  |

#### Table 5. A64 Peripherals, System Module, and Flash Base Addresses



#### Interrupt Priority

The central interrupt manager (CIM) portion of the SYS module manages the interrupt requests from the device modules (i.e., SPI1 or SPI2, SCI1 or SCI2, and RTI, etc.).

Although the CIM can accept up to 32 interrupt request signals, the A64 device only uses 21 of those interrupt request signals. The request channels are maskable so that individual channels can be selectively disabled. All interrupt requests can be programmed in the CIM to be of either type:

- Fast interrupt request (FIQ)
- Normal interrupt request (IRQ)

The precedences of request channels decrease with ascending channel order in the CIM (0, highest, and 31, lowest, priority). For these channel priorities and the associated modules, see Table 6.

| MODULES   | INTERRUPT SOURCES         | INTERRUPT LEVEL/CHANNEL |
|-----------|---------------------------|-------------------------|
| SPI1      | SPI1 end-transfer/overrun | 0                       |
| RTI       | COMP2 interrupt           | 1                       |
| RTI       | COMP1 interrupt           | 2                       |
| RTI       | TAP interrupt             | 3                       |
| SPI2      | SPI2 end-transfer/overrun | 4                       |
| GIO       | Interrupt A               | 5                       |
| Reserved  |                           | 6                       |
| HET       | Interrupt A               | 7                       |
| Reserved  |                           | 8                       |
| SCI1/SCI2 | SCI1/SCI2 error interrupt | 9                       |
| SCI1      | SCI1 receive interrupt    | 10                      |
| C2Sla     | C2SIa interrupt           | 11                      |
| Reserved  |                           | 12                      |
| Reserved  |                           | 13                      |
| SCC       | Interrupt A               | 14                      |
| Reserved  |                           | 15                      |
| MibADC    | End event conversion      | 16                      |
| SCI2      | SCI2 receive interrupt    | 17                      |
| Reserved  |                           | 18                      |
| Reserved  |                           | 19                      |
| SCI1      | SCI1 transmit interrupt   | 20                      |
| System    | SW interrupt (SSI)        | 21                      |
| Reserved  |                           | 22                      |
| HET       | Interrupt B               | 23                      |
| Reserved  |                           | 24                      |
| SCC       | Interrupt B               | 25                      |
| SCI2      | SCI2 transmit interrupt   | 26                      |
| MibADC    | End Group 1 conversion    | 27                      |
| Reserved  |                           | 28                      |
| GIO       | Interrupt B               | 29                      |
| MibADC    | End Group 2 conversion    | 30                      |
| Reserved  |                           | 31                      |

#### **Table 6. Interrupt Priority**

### MibADC

The multi-buffered analog-to-digital converter (MibADC) accepts an analog signal and converts the signal to a 10-bit digital value.

The A64 MibADC module can function in two modes: compatibility mode, where its programmer's model is compatible with the TMS470R1x ADC module and its digital results are stored in digital result registers; or in buffered mode, where the digital result registers are replaced with three FIFO buffers, one for each conversion group (event, group1 [G1], and group2 [G2]). In buffered mode, the MibADC buffers can be serviced by interrupts.

#### MibADC event trigger enhancements

The MibADC includes two major enhancements over the event-triggering capability of the TMS470R1x ADC.

- Both group1 and the event group can be configured for event-triggered operation, providing up to two event-triggered groups.
- The trigger source and polarity can be selected individually for both group1 and the event group from the three options identified in Table 7.

| EVENT # | SOURCE SELECT BITS FOR G1 OR EVENT<br>(G1SRC[1:0] or EVSRC[1:0]) | SIGNAL PIN NAME |
|---------|--|-----------------|
| EVENT1  | 00   | ADEVT           |
| EVENT2  | 01   | HET18           |
| EVENT3  | 10   | HET19           |
| EVENT4  | 11   | Reserved        |

#### Table 7. MibADC Event Hookup Configuration

For group 1, these event-triggered selections are configured via the group1 source select bits (G1SRC[1:0]) in the AD event source register (ADEVTSRC[5:4]). For the event group, these event-triggered selections are configured via the event group source select bits (EVSRC[1:0]) in the AD event source register (ADEVTSRC[1:0]).

For more detailed functional information on the MibADC, see the TMS470R1x Multi-Buffered Analog-to-Digital Converter (MibADC) Reference Guide (literature number SPNU206).



#### **Documentation Support**

Extensive documentation supports all of the TMS470 microcontroller family generation of devices. The types of documentation available include: data sheets with design specifications; complete user's guides; and errata sheets. Useful reference documentation includes:

- Bulletin
  - TMS470 Microcontroller Family Product Bulletin (literature number SPNB086)
- User's Guides
  - TMS470R1x System Module Reference Guide (literature number SPNU189)
  - TMS470R1x General-Purpose Input/Output (GIO) Reference Guide (literature number SPNU192)
  - TMS470R1x Direct Memory Access (DMA) Controller Reference Guide (literature number SPNU194)
  - TMS470R1x Serial Peripheral Interface (SPI) Reference Guide (literature number SPNU195)
  - TMS470R1x Serial Communication Interface (SCI) Reference Guide (literature number SPNU196)
  - TMS470R1x Controller Area Network (CAN) Reference Guide (literature number SPNU197)
  - TMS470R1x High End Timer (HET) Reference Guide (literature number SPNU199)
  - TMS470R1x External Clock Prescale (ECP) Reference Guide (literature number SPNU202)
  - TMS470R1x MultiBuffered AnalogtoDigital (MibADC) Reference Guide (literature number SPNU206)
  - TMS470R1x ZeroPin PhaseLocked Loop (ZPLL) Clock Module Reference Guide (literature number SPNU212)
  - TMS470R1x F05 Flash Reference Guide (literature number SPNU213)
  - TMS470R1x Class II Serial Interface B (C2SIb) Reference Guide (literature number SPNU214)
  - TMS470R1x Class II Serial Interface A (C2SIa) Reference Guide (literature number SPNU218)
  - TMS470R1x Inter-Integrated Circuit (I2C) Reference Guide (literature number SPNU223)
  - TMS470 Peripherals Overview Reference Guide (literature number SPNU248)
- Errata Sheet:
  - TMS470R1A64 TMS470 Microcontrollers Silicon Errata (literature number SPNZ134)

#### **Device and Development-Support Tool Nomenclature**

To designate the stages in the product development cycle, TI assigns prefixes to the part numbers of all DSP devices and support tools. Each DSP commercial family member has one of three prefixes: TMX, TMP, or TMS (e.g., **TMS**470R1A64). Texas Instruments recommends two of three possible prefix designators for its support tools: TMDX and TMDS. These prefixes represent evolutionary stages of product development from engineering prototypes (TMX/TMDX) through fully qualified production devices/tools (TMS/TMDS).

Device development evolutionary flow:

- **TMX** Experimental device that is not necessarily representative of the final device's electrical specifications
- **TMP** Final silicon die that conforms to the device's electrical specifications but has not completed quality and reliability verification
- **TMS** Fully qualified production device

Support tool development evolutionary flow:

- **TMDX** Development-support product that has not yet completed Texas Instruments internal qualification testing.
- **TMDS** Fully qualified development-support product

TMX and TMP devices and TMDX development-support tools are shipped against the following disclaimer:

"Developmental product is intended for internal evaluation purposes."

TMS devices and TMDS development-support tools have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI's standard warranty applies.

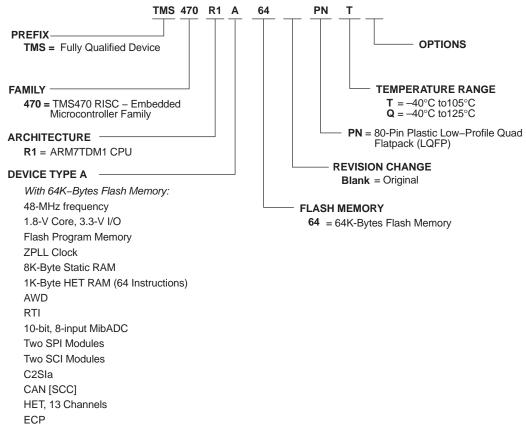
Predictions show that prototype devices (TMX or TMP) have a greater failure rate than the standard production devices. Texas Instruments recommends that these devices not be used in any production system because their expected end-use failure rate still is undefined. Only qualified production devices are to be used.

Figure 2 illustrates the numbering and symbol nomenclature for the TMS470R1x family.

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#### **Device Identification Code Register**

The device identification code register identifies the silicon version, the technology family (TF), a ROM or flash device, and an assigned device-specific part number (see Figure 3 and Table 8). The A64 device identification code register value is 0xn83F.

#### Figure 3. TMS470 Device ID Bit Allocation Register [offset = FFFF\_FF0]

| 31 | 5       |    |     |     |   |             |   |     |     | 16  |
|----|---------|----|-----|-----|---|-------------|---|-----|-----|-----|
|    |         |    |     |     |   | Reserved    |   |     |     |     |
| 15 |         | 12 | 11  | 10  | 9 |             | 3 | 2   | 1   | 0   |
|    | VERSION |    | TF  | R/F |   | PART NUMBER |   | 1   | 1   | 1   |
|    | R-K     |    | R-K | R-K |   | R-K         |   | R-1 | R-1 | R-1 |

LEGEND: R = Read only; -K = value constant after RESET; -1 = value after RESET

#### Table 8. TMS470 Device ID Bit Allocation Register Description

| BIT   | NAME        | Value | DESCRIPTION   |
|-------|-------------|-------|---|
| 31–16 | Reserved    |       | Reads are undefined and writes have no effect.  |
| 15–12 | VERSION     |       | Silicon version (revision)<br>These bits identify the silicon version of the device.  |
| 11    | TF          |       | Technology Family<br>This bit distinguishes the technology family core power supply:  |
|       |             | 0     | 3.3 V for F10/C10 devices   |
|       |             | 1     | 1.8 V for F05/C05 devices   |
| 10    | R/F         |       | ROM/Flash<br>This bit distinguishes between ROM and flash devices:  |
|       |             | 0     | Flash device  |
|       |             | 1     | ROM device  |
| 9–3   | PART NUMBER |       | Device-specific part number<br>These bits identify the assigned device-specific part number. The assigned device-specific<br>part number for the A64 device is 0000111. |
| 2–0   | 1           |       | Mandatory High<br>Bits 2,1, and 0 are tied high by default.   |

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### DEVICE ELECTRICAL SPECIFICATIONS AND TIMING PARAMETERS

#### **Absolute Maximum Ratings**

Over operating free-air temperature range, T version unless otherwise noted<sup>(1)</sup>

| Supply voltage range:                                | V <sub>CC</sub> <sup>(2)</sup>  | –0.5 V to 2.5 V |
|--|---|-----------------|
| Supply voltage range:                                | $V_CCIO$ , $V_CCAD$ , $V_CCP$ (flash pump) $^{(2)}$   | –0.5 V to 4.1 V |
| Input voltage range:                                 | All input pins  | –0.5 V to 4.1 V |
| Input clamp current:                                 | I <sub>IK</sub> (V <sub>I</sub> < 0 or V <sub>I</sub> > V <sub>CCIO</sub> )<br>All pins except ADIN[0:11], PORRST, TRST , |                 |
|  | TEST and TCK  | ± 20 mA         |
|  | I <sub>IK</sub> (V <sub>I</sub> < 0 or V <sub>I</sub> > V <sub>CCAD</sub> )<br>ADIN[0:11]                                 | ±10 mA          |
| Operating free-air temperature range, T $_{\rm A}$ : | T version   | –40°C to 105°C  |
|  | Q version   | –40°C to 125°C  |
| Operating junction temperature range, T $_{\rm J}$   |   | –40°C to 150°C  |
| Storage temperature range, T <sub>stg</sub>          |   | –65°C to 150°C  |

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values are with respect to their associated grounds.

### Device Recommended Operating Conditions<sup>(1)</sup>

|                   |   |           | MIN  | NOM | MAX  | UNIT |
|-------------------|---|-----------|------|-----|------|------|
| V <sub>CC</sub>   | Digital logic and flash supply voltage (Core) |           | 1.71 |     | 2.05 | V    |
| V <sub>CCIO</sub> | Digital logic supply voltage (I/O)            |           | 3    | 3.3 | 3.6  | V    |
| V <sub>CCAD</sub> | ADC supply voltage                            |           | 3    | 3.3 | 3.6  | V    |
| V <sub>CCP</sub>  | flash pump supply voltage                     |           | 3    | 3.3 | 3.6  | V    |
| V <sub>SS</sub>   | Digital logic supply ground                   |           |      | 0   |      | V    |
| V <sub>SSAD</sub> | ADC supply ground                             |           | -0.1 |     | 0.1  | V    |
| -                 |   | T version | -40  |     | 105  | °C   |
| Τ <sub>Α</sub>    | Operating free-air temperature                | Q version | -40  |     | 125  | Ű    |
| ΤJ                | Operating junction temperature                |           | -40  |     | 150  | °C   |

(1) All voltages are with respect to  $V_{SS}$ , except  $V_{CCAD}$ , which is with respect to  $V_{SSAD}$ .

### TMS470R1A64 16/32-Bit RISC Flash Microcontroller

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### Electrical Characteristics over Recommended Operating Free-Air Temperature Range<sup>(1)</sup>

|                   | PARAMETER                                    |   | TEST CONDITIONS   | MIN                      | TYP MAX                 | UNIT |
|-------------------|--|---|---|--------------------------|-------------------------|------|
| V <sub>hys</sub>  | Input hysteresis                             |   |   | 0.15                     |                         | V    |
| V <sub>IL</sub>   | Low-level input voltage                      | All inputs <sup>(2)</sup><br>except OSCIN                                       |   | -0.3                     | 0.8                     | V    |
| 12                | 1 0  | OSCIN only  |   | -0.3                     | 0.35V <sub>CC</sub>     |      |
| V <sub>IH</sub>   | High-level input voltage                     | All inputs<br>except OSCIN  |   | 2                        | V <sub>CCIO</sub> + 0.3 | V    |
|                   | 5 1 5  |   |   | 0.65V <sub>CC</sub>      | V <sub>CC</sub> + 0.3   |      |
| V <sub>th</sub>   | Input threshold voltage                      | AWD only  |   | 1.35                     | 1.8                     | V    |
| RDS <sub>ON</sub> | Drain to source on resistance                | AWD only <sup>(3)</sup>   | V <sub>OL</sub> = 0.35 V @ I <sub>OL</sub> = 8 mA               |                          | 45                      | Ω    |
|                   | Low-level output voltage <sup>(4</sup>       | )   | I <sub>OL</sub> = I <sub>OL</sub> MAX                           |                          | 0.2 V <sub>CCIO</sub>   | v    |
| V <sub>OL</sub>   | Low-level output voltage.                    | ,   | I <sub>OL</sub> = 50 μA   |                          | 0.2                     | v    |
|                   | Lligh lovel output voltogo <sup>(4</sup>     | 1)  | I <sub>OH</sub> = I <sub>OH</sub> MIN                           | 0.8 V <sub>CCIO</sub>    |                         | v    |
| V <sub>OH</sub>   | High-level output voltage <sup>(2</sup>      | •)  | I <sub>OH</sub> = 50 μA   | V <sub>CCIO</sub> - 0 .2 |                         | v    |
| I <sub>IC</sub>   | Input clamp current (I/O p                   | ins) <sup>(5)</sup>   | $V_{I} < V_{SSIO} - 0.3 \text{ or}$<br>$V_{I} > V_{CCIO} + 0.3$ | -2                       | 2                       | mA   |
| I <sub>I</sub>    |  | I <sub>IL</sub> Pulldown  | V <sub>I</sub> = V <sub>SS</sub>                                | -1                       | 1                       |      |
|                   | Input current (I/O pins)                     | I <sub>IH</sub> Pulldown  | $V_{I} = V_{CCIO}$  | 5                        | 40                      |      |
|                   |  | I <sub>IL</sub> Pullup  | V <sub>I</sub> = V <sub>SS</sub>                                | -40                      | -5                      | μA   |
|                   |  | I <sub>IH</sub> Pullup  | V <sub>I</sub> = V <sub>CCIO</sub>                              | -1                       | 1                       |      |
|                   |  | All other pins  | No pullup or pulldown   | -1                       | 1                       |      |
|                   |  | CLKOUT,<br>AWD, TDO   | V <sub>OL</sub> = V <sub>OL</sub> MAX                           |                          | 8                       |      |
| l <sub>ol</sub>   | Low-level output current                     | RST,<br>SPI1CLK,<br>SPI1SOMI,<br>SPI1SIMO,<br>SPI2CLK,<br>SPI2SOMI,<br>SPI2SIMO | V <sub>OL</sub> = V <sub>OL</sub> MAX                           |                          | 4                       | mA   |
|                   |  | All other output pins <sup>(6)</sup>  | $V_{OL} = V_{OL} MAX$   |                          | 2                       |      |
|                   |  | CLKOUT, TDO   | V <sub>OH</sub> = V <sub>OH</sub> MIN                           | -8                       |                         |      |
| I <sub>OH</sub>   | High-level output current                    | SPI1CLK,<br>SPI1SOMI,<br>SPI1SIMO,<br>SPI2CLK,<br>SPI2SOMI,<br>SPI2SIMO         | V <sub>OH</sub> = V <sub>OH</sub> MIN                           | -4                       |                         | mA   |
|                   |  | All other output<br>pins except<br>RST <sup>(6)</sup>                           | V <sub>OH</sub> = V <sub>OH</sub> MIN                           | -2                       |                         |      |
|                   | V <sub>CC</sub> Digital supply current mode) | (operating  | SYSCLK = 48 MHz,<br>ICLK = 24 MHz, V <sub>CC</sub> = 2.05 V     |                          | 70                      | mA   |
| I <sub>CC</sub>   | V <sub>CC</sub> Digital supply current       | (standby mode)  | OSCIN = 6 MHz, V <sub>CC</sub> = 2.06 V                         |                          | 3.0                     | mA   |
|                   | V <sub>CC</sub> Digital supply current       | (halt mode)(7)  | V <sub>CC</sub> = 2.06 V  |                          | 1.0                     | mA   |

(1) Source currents (out of the device) are negative while sink currents (into the device) are positive.

This does not apply to the PORRST pin. For PORRST exceptions, see the RST and PORRST timings section. (2)

(3) These values help to determine the external RC network circuit. For more details, see the TMS470R1x System Module Reference Guide (literature number SPNU189).  $V_{OL}$  and  $V_{OH}$  are linear with respect to the amount of load current ( $I_{OL}/I_{OH}$ ) applied.

(4)

(5)

Parameter does not apply to input-only or output-only pins. The 2 mA buffers on this device are called zero-dominant buffers. If two of these buffers are shorted together and one is outputting a (6) low level and the other is outputting a high level, the resulting value will always be low.

(7) For flash banks/pumps in sleep mode.

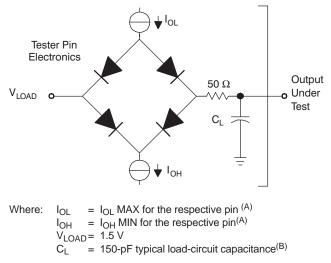


# Electrical Characteristics over Recommended Operating Free-Air Temperature Range (continued)

|                   | PARAMETER   | TEST CONDITIONS   | MIN TYP MAX | UNIT |
|-------------------|---|---|-------------|------|
|                   | V <sub>CCIO</sub> Digital supply current (operating mode) | No DC load, $V_{CCIO} = 3.6 V^{(8)}$                    | 10          | mA   |
| I <sub>CCIO</sub> | V <sub>CCIO</sub> Digital supply current (standby mode)   | No DC load, $V_{CCIO} = 3.6 V^{(8)}$                    | 300         | μA   |
|                   | V <sub>CCIO</sub> Digital supply current (halt mode)      | No DC load, $V_{CCIO} = 3.6 V^{(8)}$                    | 300         | μΑ   |
|                   | V <sub>CCAD</sub> supply current (operating mode)         | All frequencies, $V_{CCAD} = 3.6 V$                     | 15          | mA   |
| I <sub>CCAD</sub> | V <sub>CCAD</sub> supply current (standby mode)           | All frequencies, $V_{CCAD} = 3.6 V$                     | 20          | μΑ   |
| I <sub>CCAD</sub> | V <sub>CCAD</sub> supply current (halt mode)              | All frequencies, $V_{CCAD} = 3.6 V$                     | 20          | μΑ   |
|                   |   | $V_{CCP} = 3.6$ V read operation                        | 50          | mA   |
|                   |   | $V_{CCP}$ = 3.6 V program and erase                     | 70          | mA   |
| I <sub>CCP</sub>  | V <sub>CCP</sub> pump supply current                      | $V_{CCP} = 3.6 V$ standby mode operation <sup>(7)</sup> | 20          | μA   |
|                   |   | $V_{CCP} = 3.6 V$ halt mode operation <sup>(7)</sup>    | 20          | μA   |
| Cı                | Input capacitance   |   | 2           | pF   |
| С <sub>о</sub>    | Output capacitance  |   | 3           | pF   |

(8) I/O pins configured as inputs or outputs with no load. All pulldown inputs  $\leq$  0.2 V. All pullup inputs  $\geq$  V<sub>CCIO</sub> - 0.2 V.

### **Parameter Measurement Information**



- A. For these values, see the "Electrical Characteristics over Recommended Operating Free-Air Temperature Range" table.
- B. All timing parameters measured using an external load capacitance of 150 pF unless otherwise noted.

#### Figure 4. Test Load Circuit

### **Timing Parameter Symbology**

Timing parameter symbols have been created in accordance with JEDEC Standard 100. To shorten the symbols, some of the pin names and other related terminology have been abbreviated as follows:

| СМ        | Compaction, CMPCT      | RD   | Read         |
|-----------|------------------------|------|--------------|
| CO        | CLKOUT                 | RST  | Reset, RST   |
| ER        | Erase                  | RX   | SCInRX       |
| ICLK      | Interface clock        | S    | Slave mode   |
| Μ         | Master mode            | SCC  | SCInCLK      |
| OSC, OSCI | OSCIN                  | SIMO | SPInSIMO     |
| OSCO      | OSCOUT                 | SOMI | SPInSOMI     |
| Р         | Program, PROG          | SPC  | SPInCLK      |
| R         | Ready                  | SYS  | System clock |
| R0        | Read margin 0, RDMRGN0 | ТΧ   | SCInTX       |
| R1        | Read margin 1, RDMRGN1 |      |              |

Lowercase subscripts and their meanings are:

| а | access time         | r  | rise time              |
|---|---------------------|----|------------------------|
| с | cycle time (period) | su | setup time             |
| d | delay time          | t  | transition time        |
| f | fall time           | V  | valid time             |
| h | hold time           | W  | pulse duration (width) |
|   |                     |    |                        |

The following additional letters are used with these meanings:

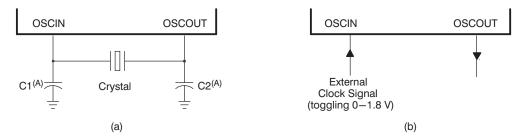
| н | High  | Х | Unknown, changing, or don't care level |
|---|-------|---|--|
| L | Low   | Z | High impedance                         |
| V | Valid |   |  |

### TMS470R1A64 16/32-Bit RISC Flash Microcontroller SPNS099B-NOVEMBER 2004-REVISED AUGUST 2006

#### External Reference Resonator/Crystal Oscillator Clock Option

The oscillator is enabled by connecting the appropriate fundamental 4–20 MHz resonator/crystal and load capacitors across the external OSCIN and OSCOUT pins as shown in Figure 5a. The oscillator is a single-stage inverter held in bias by an integrated bias resistor. This resistor is disabled during leakage test measurement and HALT mode. **TI strongly encourages each customer to submit samples of the device to the resonator/crystal vendors for validation.** The vendors are equipped to determine what load capacitors will best tune their resonator/crystal to the microcontroller device for optimum start-up and operation over temperature/voltage extremes.

An external oscillator source can be used by connecting a 1.8-V clock signal to the OSCIN pin and leaving the OSCOUT pin unconnected (open) as shown in Figure 5b.



A. The values of C1 and C2 should be provided by the resonator/crystal vendor.

Figure 5. Crystal/Clock Connection

### ZPLL AND CLOCK SPECIFICATIONS

### Timing Requirements for ZPLL Circuits Enabled or Disabled

|                       |                                   | MIN | ТҮР | MAX | UNIT |
|-----------------------|-----------------------------------|-----|-----|-----|------|
| f <sub>(OSC)</sub>    | Input clock frequency             | 4   |     | 20  | MHz  |
| t <sub>c(OSC)</sub>   | Cycle time, OSCIN                 | 50  |     |     | ns   |
| t <sub>w(OSCIL)</sub> | Pulse duration, OSCIN low         | 15  |     |     | ns   |
| t <sub>w(OSCIH)</sub> | Pulse duration, OSCIN high        | 15  |     |     | ns   |
| f <sub>(OSCRST)</sub> | OSC FAIL frequency <sup>(1)</sup> |     | 53  |     | kHz  |

(1) Causes a device reset (specifically a clock reset) by setting the RST OSC FAIL (GLBCTRL[15]) and the OSC FAIL flag (GLBSTAT[1]) bits equal to 1. For more detailed information on these bits and device resets, see the TMS470R1x System Module Reference Guide (literature number SPNU189).

### Switching Characteristics over Recommended Operating Conditions for Clocks<sup>(1)(2)</sup>

|                        | PARAMETER                                      | TEST CONDITIONS <sup>(3)</sup> | MIN  | MAX | UNIT  |
|------------------------|--|--------------------------------|------|-----|-------|
| <i>ı</i>               | System clock frequency <sup>(4)</sup>          | Pipeline mode enabled          |      | 48  | MHz   |
| f <sub>(SYS)</sub>     | System clock nequency v                        | Pipeline mode disabled         |      | 24  | IVITZ |
| f <sub>(CONFIG)</sub>  | System clock frequency - flash config mode     |                                |      | 24  | MHz   |
| 4                      | Interface cleak frequency                      | Pipeline mode enabled          |      | 25  | N41 I |
| f <sub>(ICLK)</sub>    | Interface clock frequency                      | Pipeline mode disabled         |      | 24  | MHz   |
|                        | External clock output frequency for ECP Module | Pipeline mode enabled          |      | 25  | MHz   |
| t <sub>(ECLK)</sub>    |  | Pipeline mode disabled         |      | 24  |       |
|                        | Cycle time, system clock                       | Pipeline mode enabled          | 20.8 |     | ns    |
| t <sub>c(SYS)</sub>    |  | Pipeline mode disabled         | 41.6 |     |       |
| t <sub>c(CONFIG)</sub> | Cycle time, system clock - flash config mode   |                                | 41.6 |     | ns    |
|                        |  | Pipeline mode enabled          | 40   |     |       |
| t <sub>c(ICLK)</sub>   | Cycle time, interface clock                    | Pipeline mode disabled         | 41.6 |     | ns    |
|                        | Quele time. EQD module external clash extruit  | Pipeline mode enabled          | 40   |     |       |
| t <sub>c(ECLK)</sub>   | Cycle time, ECP module external clock output   | Pipeline mode disabled         | 41.6 |     | ns    |

 $f_{(SYS)} = M \times f_{(OSC)}/R$ , where M = {4 or 8}, R = {1,2,3,4,5,6,7,8} when PLLDIS = 0. R is the system-clock divider determined by the CLKDIVPRE [2:0] bits in the global control register (GLBCTRL[2:0]) and M is the PLL multiplier determined by the MULT4 bit also in the (1) GLBCTRL register (GLBCTRL.3).

 $f_{(SYS)} = f_{(OSC)}/R$ , where R = {1,2,3,4,5,6,7,8} when PLLDIS = 1.

 $f_{(ICLK)} = f_{(SYS)}/X$ , where X = {1,2,3,4,5,6,7,8,9,10,11,12,13,14,15,16}. X is the interface clock divider ratio determined by the PCR0[4:1] bits in the SYS module.

 $f_{(ECLK)} = f_{(ICLK)}/N$ , where N = {1 to 256}. N is the ECP prescale value defined by the ECPCTRL[7:0] register bits in the ECP module. Pipeline mode enabled or disabled is determined by the ENPIPE bit (FMREGOPT[0]). (2)

(3)

(4) Flash Vread must be set to 5V to achieve maximum system clock frequency.



# Switching Characteristics over Recommended Operating Conditions for External Clocks<sup>(1)(2)(3)</sup>

### (See Figure 6 and Figure 7)

|                     | PARAMETER                   | TEST CONDITION                          | MIN  | MAX | UNIT |
|---------------------|-----------------------------|---|--|-----|------|
|                     |                             | SYSCLK or MCLK <sup>`(4)</sup>          | $0.5t_{c(SYS)} - t_{f}$                                |     |      |
| t <sub>w(COL)</sub> | Pulse duration, CLKOUT low  | ICLK, X is even or 1 <sup>(5)</sup>     | $0.5t_{c(ICLK)} - t_{f}$                               |     | ns   |
|                     |                             | ICLK, X is odd and not 1 <sup>(5)</sup> | $0.5t_{c(ICLK)} + 0.5t_{c(SYS)} - t_{f}$               |     |      |
|                     |                             | SYSCLK or MCLK <sup>(4)</sup>           | $0.5t_{c(SYS)} - t_r$                                  |     |      |
| t <sub>w(COH)</sub> | Pulse duration, CLKOUT high | ICLK, X is even or 1 <sup>(5)</sup>     | $0.5t_{c(ICLK)} - tr$                                  |     | ns   |
|                     |                             | ICLK, X is odd and not 1 <sup>(5)</sup> | $0.5 t_{c(\text{ICLK})} - 0.5 t_{c(\text{SYS})} - t_r$ |     |      |
|                     |                             | N is even and X is even or odd          | $0.5t_{c(ECLK)} - t_{f}$                               |     |      |
| t <sub>w(EOL)</sub> | Pulse duration, ECLK low    | N is odd and X is even                  | $0.5t_{c(ECLK)} - t_{f}$                               |     | ns   |
|                     |                             | N is odd and X is odd and not 1         | $0.5t_{c(ECLK)}$ + $0.5t_{c(SYS)}$ – $t_f$             |     |      |
|                     |                             | N is even and X is even or odd          | $0.5t_{c(ECLK)} - t_r$                                 |     |      |
| t <sub>w(EOH)</sub> | Pulse duration, ECLK high   | N is odd and X is even                  | $0.5t_{c(ECLK)} - t_r$                                 |     | ns   |
|                     |                             | N is odd and X is odd and not 1         | $0.5t_{c(\text{ECLK})} - 0.5t_{c(\text{SYS})} - t_{r}$ |     |      |

X = {1,2,3,4,5,6,7,8,9,10,11,12,13,14,15,16}. X is the interface clock divider ratio determined by the PCR0[4:1] bits in the SYS module.
 N = {1 to 256}. N is the ECP prescale value defined by the ECPCTRL[7:0] register bits in the ECP module.
 CLKOUT/ECLK pulse durations (low/high) are a function of the OSCIN pulse durations when PLLDIS is active.

(4) Clock source bits selected as either SYSCLK (CLKCNTL[6:5] = 11 binary) or MCLK (CLKCNTL[6:5] = 10 binary).
 (5) Clock source bits selected as ICLK (CLKCNTL[6:5] = 01 binary).

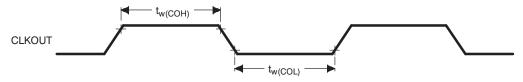


Figure 6. CLKOUT Timing Diagram

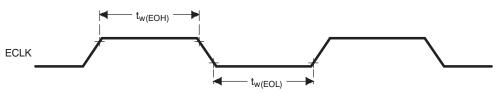


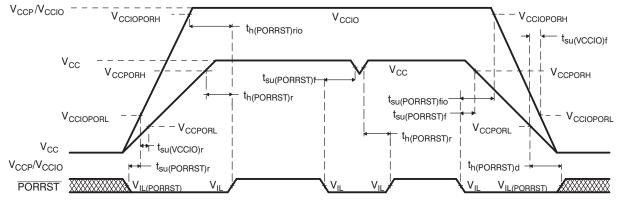
Figure 7. ECLK Timing Diagram

### **RST AND PORRST TIMINGS**

### Timing Requirements for PORRST

(see Figure 8)

|                            |  | MIN  | MAX           | UNIT |
|----------------------------|--|------|---------------|------|
| V <sub>CCPORL</sub>        | V <sub>CC</sub> low supply level when PORRST must be active during power up  |      | 0.6           | V    |
| V <sub>CCPORH</sub>        | $V_{CC}$ high supply level when $\overline{\text{PORRST}}$ must remain active during power up and become active during power down          | 1.5  |               | V    |
| V <sub>CCIOPORL</sub>      | V <sub>CCIO</sub> low supply level when PORRST must be active during power up  |      | 1.1           | V    |
| V <sub>CCIOPORH</sub>      | $V_{\text{CCIO}}$ high supply level when $\overline{\text{PORRST}}$ must remain active during power up and become active during power down | 2.75 |               | V    |
| V <sub>IL</sub>            | Low-level input voltage after V <sub>CCIO</sub> > V <sub>CCIOPORH</sub>  |      | $0.2V_{CCIO}$ | V    |
| V <sub>IL(PORRST)</sub>    | Low-level input voltage of PORRST before V <sub>CCIO</sub> > V <sub>CCIOPORL</sub>   |      | 0.5           | V    |
| t <sub>su(PORRST)</sub> r  | Setup time, $\overline{\text{PORRST}}$ active before $V_{CCIO} > V_{CCIOPORL}$ during power up   | 0    |               | ms   |
| t <sub>su(VCCIO)</sub> r   | Setup time, $V_{CCIO} > V_{CCIOPORL}$ before $V_{CC} > V_{CCPORL}$   | 0    |               | ms   |
| t <sub>h(PORRST)</sub>     | Hold time, $\overline{PORRST}$ active after $V_{CC} > V_{CCPORH}$  | 1    |               | ms   |
| t <sub>su(PORRST)f</sub>   | Setup time, $\overrightarrow{PORRST}$ active before $V_{CC} \leq V_{CCPORH}$ during power down   | 8    |               | ms   |
| t <sub>h(PORRST)rio</sub>  | Hold time, $\overline{PORRST}$ active after $V_{CC} > V_{CCIOPORH}$  | 1    |               | ms   |
| t <sub>h(PORRST)d</sub>    | Hold time, PORRST active after V <sub>CC</sub> < V <sub>CCPORL</sub>   | 0    |               | ms   |
| t <sub>su(PORRST)fio</sub> | Setup time, $\overline{\text{PORRST}}$ active before $V_{CC} \leq V_{CCIOPORH}$ during power down  | 0    |               | ms   |
| t <sub>su(VCCIO)f</sub>    | Setup time, V <sub>CC</sub> < V <sub>CCPORL</sub> before V <sub>CCIO</sub> < V <sub>CCIOPORL</sub>   | 0    |               | ms   |



NOTE:  $V_{CCIO} > 1.1 \text{ V}$  before  $V_{CC} > 0.6 \text{ V}$ 

### Figure 8. PORRST Timing Diagram

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# Switching Characteristics over Recommended Operating Conditions for $\overline{\text{RST}^{(1)}}$

|                  | PARAMETER   | MIN                     | MAX | UNIT |
|------------------|---|-------------------------|-----|------|
| tu(per)          | Valid time, RST active after PORRST inactive  | 4112t <sub>c(OSC)</sub> |     | 20   |
|                  | Valid time, RST active (all others)   | 8t <sub>c(SYS)</sub>    |     | ns   |
| T <sub>fsu</sub> | Flash start-up time, from $\overline{\text{RST}}$ inactive to fetch of first instruction from flash (flash pump stabilization time) | 336t <sub>c(OSC)</sub>  |     | ns   |

(1) Specified values do NOT include rise/fall times. For rise and fall timings, see the "Switching Characteristics for Output Timings versus Load Capacitance" table.

### JTAG SCAN INTERFACE TIMING

(JTAG clock specification 10-MHz and 50-pF load on TDO output)

|                                 |   | MIN | MAX | UNIT |
|---------------------------------|---|-----|-----|------|
| t <sub>c(JTAG)</sub>            | Cycle time, JTAG low and high period        | 50  |     | ns   |
| t <sub>su(TDI/TMS</sub> - TCKr) | Setup time, TDI, TMS before TCK rise (TCKr) | 15  |     | ns   |
| t <sub>h(TCKr</sub> -TDI/TMS)   | Hold time, TDI, TMS after TCKr              | 15  |     | ns   |
| t <sub>h(TCKf</sub> -TDO)       | Hold time, TDO after TCKf                   | 10  |     | ns   |
| t <sub>d(TCKf</sub> -TDO)       | Delay time, TDO valid after TCK fall (TCKf) |     | 45  | ns   |

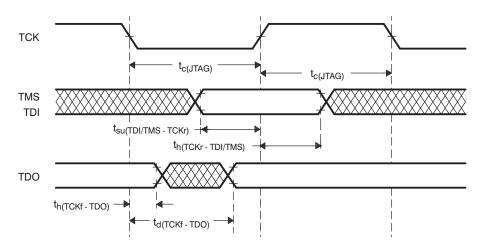


Figure 9. JTAG Scan Timings

### **OUTPUT TIMINGS**

### Switching Characteristics for Output Timings versus Load Capacitance $\mathbb{O}_L$ )

(See Figure 10)

|                | PARAMETER  |                         | MIN | MAX  | UNIT |
|----------------|--|-------------------------|-----|------|------|
|                |  | C <sub>L</sub> = 15 pF  | 0.5 | 2.50 |      |
|                |  | $C_L = 50 \text{ pF}$   | 1.5 | 5    |      |
| t <sub>r</sub> | Rise time, CLKOUT, AWD, TDO                      | C <sub>L</sub> = 100 pF | 3   | 9    | ns   |
|                |  | C <sub>L</sub> = 150 pF | 4.5 | 12.5 |      |
|                |  | C <sub>L</sub> = 15 pF  | 0.5 | 2.5  |      |
|                |  | C <sub>L</sub> = 50 pF  | 1.5 | 5    | 20   |
| t <sub>f</sub> | Fall time, CLKOUT, AWD, TDO                      | C <sub>L</sub> = 100 pF | 3   | 9    | ns   |
|                |  | C <sub>L</sub> = 150 pF | 4.5 | 12.5 |      |
|                |  | C <sub>L</sub> = 15 pF  | 2.5 | 8    | ns   |
|                | Rise time, SPI1CLK, SPI1SOMI, SPI1SIMO, SPI2CLK, | C <sub>L</sub> = 50 pF  | 5   | 14   |      |
| t <sub>r</sub> | SPI2SOMI, SPI2SIMO                               | C <sub>L</sub> = 100 pF | 9   | 23   |      |
|                |  | C <sub>L</sub> = 150 pF | 13  | 32   |      |
|                |  | C <sub>L</sub> = 15 pF  | 2.5 | 8    |      |
|                | Fall time, RST, SPI1CLK, SPI1SOMI, SPI1SIMO,     | C <sub>L</sub> = 50 pF  | 5   | 14   |      |
| t <sub>f</sub> | SPI2CLK, SPI2SOMI, SPI2SIMO                      | C <sub>L</sub> = 100 pF | 9   | 23   | ns   |
|                |  | C <sub>L</sub> = 150 pF | 13  | 32   |      |
|                |  | C <sub>L</sub> = 15 pF  | 2.5 | 10   |      |
|                |  | C <sub>L</sub> = 50 pF  | 6.0 | 25   |      |
| t <sub>r</sub> | Rise time, all other output pins                 | C <sub>L</sub> = 100 pF | 12  | 45   | ns   |
|                |  | C <sub>L</sub> = 150 pF | 18  | 65   |      |
|                |  | C <sub>L</sub> = 15 pF  | 3   | 10   |      |
|                |  | C <sub>L</sub> = 50 pF  | 8.5 | 25   |      |
| t <sub>f</sub> | Fall time, all other output pins                 | C <sub>L</sub> = 100 pF | 16  | 45   | ns   |
|                |  | C <sub>L</sub> = 150 pF | 23  | 65   |      |



Figure 10. CMOS-Level Outputs

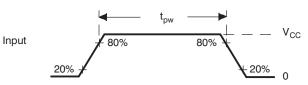
#### **INPUT TIMINGS**

### Timing Requirements for Input Timings<sup>(1)</sup>

(See Figure 11)



(1)  $t_{c(ICLK)}$  = interface clock cycle time =  $1/f_{(ICLK)}$ 





### **FLASH TIMINGS**

# Timing Requirements for Program Flash<sup>(1)</sup>

|                            |  | MIN   | TYP                   | MAX | UNIT   |
|----------------------------|--|-------|-----------------------|-----|--------|
| t <sub>prog(16-bit)</sub>  | Half word (16-bit) programming time                          | 4     | 16                    | 200 | μs     |
| t <sub>prog(Total)</sub>   | 64K-byte programming time <sup>(2)</sup>                     |       | 0.5                   | 2   | s      |
| t <sub>erase(sector)</sub> | Sector erase time  |       | 1.7                   |     | s      |
| t <sub>wec</sub>           | Write/erase cycles at $T_A = -40^{\circ}C$ to $125^{\circ}C$ | 50000 |                       |     | cycles |
| t <sub>fp(RST)</sub>       | Flash pump settling time from RST to SLEEP                   |       | 67t <sub>c(SYS)</sub> |     | ns     |
| t <sub>fp(SLEEP)</sub>     | Initial flash pump settling time from SLEEP to STANDBY       |       | 67t <sub>c(SYS)</sub> |     | ns     |
| t <sub>fp(STANDBY)</sub>   | Initial flash pump settling time from STANDBY to ACTIVE      |       | 34t <sub>c(SYS)</sub> |     | ns     |

(1) For more detailed information on the flash core sectors, see the *Flash program and erase section* of this data sheet.
 (2) The 64K-byte programming times include overhead of state machine.

### SPIn MASTER MODE TIMING PARAMETERS

### **SPIn Master Mode External Timing Parameters**

(CLOCK PHASE = 0, SPInCLK = output, SPInSIMO = output, and SPInSOMI = input)<sup>(1)(2)(3)</sup> (see Figure 12)

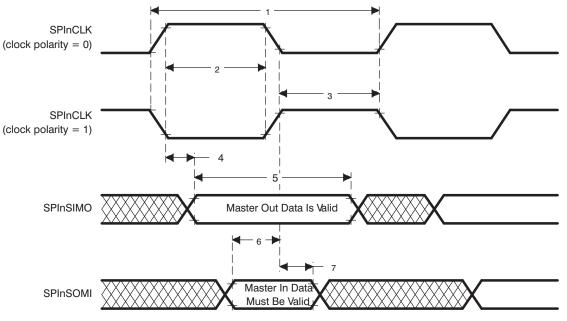
| NO.              |                             |   | MIN                        | MAX                         | UNIT |
|------------------|-----------------------------|---|----------------------------|-----------------------------|------|
| 1                | t <sub>c(SPC)M</sub>        | Cycle time, SPInCLK <sup>(4)</sup>                                      | 100                        | 256t <sub>c(ICLK)</sub>     | ns   |
| 2 <sup>(5)</sup> | t <sub>w(SPCH)M</sub>       | Pulse duration, SPInCLK high (clock polarity = 0)                       | $0.5t_{c(SPC)M} - t_r$     | 0.5t <sub>c(SPC)M</sub> + 5 | -    |
| Ζ(0)             | t <sub>w(SPCL)M</sub>       | Pulse duration, SPInCLK low (clock polarity = 1)                        | $0.5t_{c(SPC)M} - t_{f}$   | $0.5t_{c(SPC)M} + 5$        | ns   |
| 3(5)             | t <sub>w(SPCL)M</sub>       | Pulse duration, SPInCLK low (clock polarity = 0)                        | $0.5t_{c(SPC)M} - t_{f}$   | $0.5t_{c(SPC)M} + 5$        | ns   |
| 3.47             | t <sub>w(SPCH)M</sub>       | Pulse duration, SPInCLK high (clock polarity = 1)                       | $0.5t_{c(SPC)M} - t_r$     | $0.5t_{c(SPC)M} + 5$        | 115  |
| 4 <sup>(5)</sup> | t <sub>d(SPCH</sub> -SIMO)M | Delay time, SPInCLK high to SPInSIMO valid (clock polarity = 0)         | 0                          | 10                          | ns   |
|                  | t <sub>d(SPCL-SIMO)M</sub>  | Delay time, SPInCLK low to SPInSIMO valid (clock polarity = 1)          | 0                          | 10                          |      |
| 5(5)             | t <sub>v(SPCL-SIMO)M</sub>  | Valid time, SPInSIMO data valid after SPInCLK low (clock polarity = 0)  | $t_{c(SPC)M} - 5 - t_{f}$  |                             | 20   |
| 3(0)             | t <sub>v(SPCH-SIMO)M</sub>  | Valid time, SPInSIMO data valid after SPInCLK high (clock polarity = 1) | $t_{c(\text{SPC})M}-5-t_r$ |                             | – ns |
| 6 <sup>(5)</sup> | t <sub>su(SOMI-SPCL)M</sub> | Setup time, SPInSOMI before SPInCLK low<br>(clock polarity = 0)         | 6                          |                             | 20   |
| 0(0)             | t <sub>su(SOMI-SPCH)M</sub> | Setup time, SPInSOMI before SPInCLK high (clock polarity = 1)           | 6                          |                             | – ns |
| 7(5)             | t <sub>v(SPCL-SOMI)M</sub>  | Valid time, SPInSOMI data valid after SPInCLK low (clock polarity = 0)  | 4                          |                             | 20   |
| 1 (3)            | t <sub>v(SPCH-SOMI)M</sub>  | Valid time, SPInSOMI data valid after SPInCLK high (clock polarity = 1) | 4                          |                             | – ns |

(1) The MASTER bit (SPInCTRL2.3) is set and the CLOCK PHASE bit (SPInCTRL2[0]) is cleared.

(2)

 $t_{c(ICLK)}$  = interface clock cycle time = 1/f<sub>(ICLK)</sub> For rise and fall timings, see the "Switching Characteristics for Output Timings versus Load Capacitance" table. (3)

(4) When the SPI is in master mode, the following must be true: For PS values from 1 to 255:  $t_{c(SPC)M} \ge (PS + 1)t_{c(ICLK)} \ge 100$  ns, where PS is the prescale value set in the SPInCTL1[12:5] register bits. For PS values of 0:  $t_{c(SPC)M} = 2t_{c(ICLK)} \ge 100$  ns. (5) The active edge of the SPInCLK signal referenced is controlled by the CLOCK POLARITY bit (SPInCTRL2[1]).





### SPIn Master Mode External Timing Parameters

(CLOCK PHASE = 1, SPInCLK = output, SPInSIMO = output, and SPInSOMI = input)<sup>(1)(2)(3)</sup> (see Figure 13)

| NO.  |                             |   | MIN                          | MAX                     | UNIT |
|--|-----------------------------|---|------------------------------|-------------------------|------|
| 1  | t <sub>c(SPC)M</sub>        | Cycle time, SPInCLK <sup>(4)</sup>                                      | 100                          | 256t <sub>c(ICLK)</sub> | ns   |
| 2 <sup>(5)</sup>                               | t <sub>w(SPCH)M</sub>       | Pulse duration, SPInCLK high (clock polarity = 0)                       | $0.5t_{c(SPC)M} - t_r$       | $0.5t_{c(SPC)M} + 5$    |      |
| 2(0)   | t <sub>w(SPCL)M</sub>       | Pulse duration, SPInCLK low (clock polarity = 1)                        | $0.5t_{c(SPC)M} - t_{f}$     | $0.5t_{c(SPC)M} + 5$    | ns   |
| 3 <sup>(5)</sup> t <sub>w(SPCL)</sub>          | t <sub>w(SPCL)M</sub>       | Pulse duration, SPInCLK low (clock polarity = 0)                        | $0.5t_{c(SPC)M} - t_{f}$     | $0.5t_{c(SPC)M} + 5$    | ns   |
| 3(0)   | t <sub>w(SPCH)M</sub>       | Pulse duration, SPInCLK high (clock polarity = 1)                       | $0.5t_{c(SPC)M} - t_r$       | $0.5t_{c(SPC)M} + 5$    | 115  |
| 4 (5)  | t <sub>v(SIMO-SPCH)M</sub>  | Valid time, SPInCLK high after SPInSIMO data valid (clock polarity = 0) | 0.5t <sub>c(SPC)M</sub> - 10 |                         |      |
| 4 <sup>(5)</sup>                               | t <sub>v(SIMO-SPCL)M</sub>  | Valid time, SPInCLK low after SPInSIMO data valid (clock polarity = 1)  | 0.5t <sub>c(SPC)M</sub> – 10 |                         | ns   |
| r (6)  | t <sub>v(SPCH-SIMO)M</sub>  | Valid time, SPInSIMO data valid after SPInCLK high (clock polarity = 0) | $t_{c(SPC)M} - 5 - t_{f}$    |                         |      |
| 5 <sup>(6)</sup><br>t <sub>v(SPCL-SIMO)M</sub> |                             | Valid time, SPInSIMO data valid after SPInCLK low (clock polarity = 1)  | $t_{c(SPC)M} - 5 - t_r$      |                         | - ns |
| 6 <sup>(5)</sup>                               | t <sub>su(SOMI-SPCH)M</sub> | Setup time, SPInSOMI before SPInCLK high (clock polarity = 0)           | 6                            |                         |      |
| 0(0)   | t <sub>su(SOMI-SPCL)M</sub> | Setup time, SPInSOMI before SPInCLK low<br>(clock polarity = 1)         | 6                            |                         | - ns |
| 7(5)   | t <sub>v(SPCH-SOMI)M</sub>  | Valid time, SPInSOMI data valid after SPInCLK high (clock polarity = 0) | 4                            |                         |      |
| 1.0)   | t <sub>v(SPCL-SOMI)M</sub>  | Valid time, SPInSOMI data valid after SPInCLK low (clock polarity = 1)  | 4                            |                         | - ns |

(1) The MASTER bit (SPInCTRL2.3) is set and the CLOCK PHASE bit (SPInCTRL2[0]) is set.

 (2) t<sub>c(ICLK)</sub> = interface clock cycle time = 1/f<sub>(ICLK)</sub>
 (3) For rise and fall timings, see the "Switching Characteristics for Output Timings versus Load Capacitance" table.
 (4) When the SPI is in master mode, the following must be true: For PS values from 1 to 255: t<sub>c(SPC)M</sub> ≥ (PS +1)t<sub>c(ICLK)</sub> ≥ 100 ns, where PS is the prescale value set in the SPInCTL1[12:5] register bits. For PS values of 0: t<sub>c(SPC)M</sub> = 2t<sub>c(ICLK)</sub> ≥ 100 ns.
 (5) The active edge of the SPInCLK signal referenced is controlled by the clock polarity bit (SPInCTRL2[1]).

(6) The active edge of the SPInCLK signal referenced is controlled by the clock polarity bit (SPInCTRL2[1]).

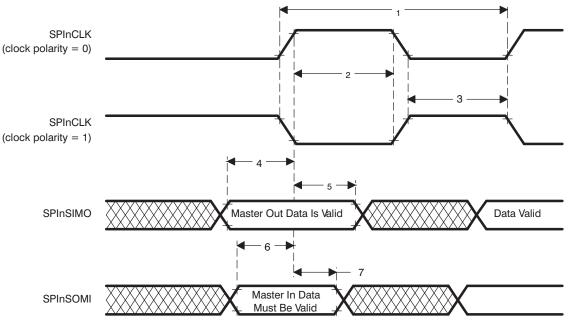


Figure 13. SPIn Master Mode External Timing (CLOCK PHASE = 1)

### SPIn SLAVE MODE TIMING PARAMETERS

### **SPIn Slave Mode External Timing Parameters**

(CLOCK PHASE = 0, SPInCLK = input, SPInSIMO = input, and SPInSOMI = output)<sup>(1)(2)(3)(4)</sup> (see Figure 14)

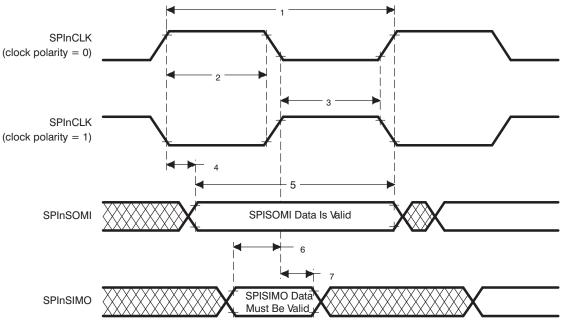
| NO.              |                                 |   | MIN                                | МАХ                                | UNI<br>T |
|------------------|---------------------------------|---|------------------------------------|------------------------------------|----------|
| 1                | t <sub>c(SPC)S</sub>            | Cycle time, SPInCLK <sup>(5)</sup>  | 100                                | 256t <sub>c(ICLK)</sub>            | ns       |
| 2(6)             | t <sub>w(SPCH)S</sub>           | Pulse duration, SPInCLK high (clock polarity = 0)                             | $0.5t_{c(SPC)S} - 0.25t_{c(ICLK)}$ | $0.5t_{c(SPC)S} + 0.25t_{c(ICLK)}$ | ns       |
| 2(-)             | t <sub>w(SPCL)S</sub>           | Pulse duration, SPInCLK low (clock polarity = 1)                              | $0.5t_{c(SPC)S} - 0.25t_{c(ICLK)}$ | $0.5t_{c(SPC)S} + 0.25t_{c(ICLK)}$ | 115      |
| 3(6)             | t <sub>w(SPCL)S</sub>           | Pulse duration, SPInCLK low (clock polarity = 0)                              | $0.5t_{c(SPC)S} - 0.25t_{c(ICLK)}$ | $0.5t_{c(SPC)S} + 0.25t_{c(ICLK)}$ | ns       |
| 3.07             | t <sub>w(SPCH)S</sub>           | Pulse duration, SPInCLK high (clock polarity = 1)                             | $0.5t_{c(SPC)S} - 0.25t_{c(ICLK)}$ | $0.5t_{c(SPC)S} + 0.25t_{c(ICLK)}$ | 115      |
| 4(6)             | t <sub>d(SPCH-</sub><br>SOMI)S  | Delay time, SPInCLK high to SPInSOMI valid (clock polarity = 0)               |                                    | 6 + t <sub>r</sub>                 | 20       |
| 4(*)             | t <sub>d(SPCL</sub> -<br>SOMI)S | Delay time, SPInCLK low to SPInSOMI valid<br>(clock polarity = 1)             |                                    | 6 + t <sub>f</sub>                 | ns       |
| 5(6)             | t <sub>v(SPCH-</sub><br>SOMI)S  | Valid time, SPInSOMI data valid after SPInCLK<br>high<br>(clock polarity = 0) | $t_{c(SPC)S} - 6 - t_r$            |                                    | ns       |
|                  | t <sub>v(SPCL</sub> -<br>SOMI)S | Valid time, SPInSOMI data valid after SPInCLK low (clock polarity = 1)        | $t_{c(SPC)S} - 6 - t_{f}$          |                                    | -        |
| 6 <sup>(6)</sup> | t <sub>su(SIMO-</sub><br>SPCL)S | Setup time, SPInSIMO before SPInCLK low (clock polarity = 0)                  | 6                                  |                                    | -        |
| 0(-)             | t <sub>su(SIMO-</sub><br>SPCH)S | Setup time, SPInSIMO before SPInCLK high (clock polarity = 1)                 | 6                                  |                                    | ns       |
|                  | t <sub>v(SPCL</sub> -<br>SIMO)S | Valid time, SPInSIMO data valid after SPInCLK low (clock polarity = 0)        | 6                                  |                                    |          |
| 7(6)             | t <sub>v(SPCH-</sub><br>SIMO)S  | Valid time, SPInSIMO data valid after SPInCLK<br>high<br>(clock polarity = 1) | 6                                  |                                    | ns       |

(1) The MASTER bit (SPInCTRL2.3) is cleared and the CLOCK PHASE bit (SPInCTRL2[0]) is cleared.

(2) If the SPI is in slave mode, the following must be true:  $t_{c(SPC)S} \ge (PS + 1) t_{c(ICLK)}$ , where PS = prescale value set in SPInCTL1[12:5]. (3) For rise and fall timings, see the "Switching Characteristics for Output Timings versus Load Capacitance" table.

(4)  $t_{c(ICLK)}$  = interface clock cycle time =  $1/f_{(ICLK)}$ (5) When the SPIn is in slave mode, the following must be true:

(b) When both the of the both and the both





### **SPIn Slave Mode External Timing Parameters**

(CLOCK PHASE = 1, SPInCLK = input, SPInSIMO = input, and SPInSOMI = output) (1)(2)(3)(4) (see Figure 15)

| NO.              |                                 |   | MIN   | МАХ                                | UNI<br>T |
|------------------|---------------------------------|---|---|------------------------------------|----------|
| 1                | t <sub>c(SPC)S</sub>            | Cycle time, SPInCLK <sup>(5)</sup>                                      | 100   | 256t <sub>c(ICLK)</sub>            | ns       |
| 2 <sup>(6)</sup> | t <sub>w(SPCH)S</sub>           | Pulse duration, SPInCLK high (clock polarity = 0)                       | $0.5t_{c(SPC)S} - 0.25t_{c(ICLK)}$          | $0.5t_{c(SPC)S} + 0.25t_{c(ICLK)}$ | ns       |
| 2(-)             | t <sub>w(SPCL)S</sub>           | Pulse duration, SPInCLK low (clock polarity = 1)                        | $0.5t_{c(SPC)S} - 0.25t_{c(ICLK)}$          | $0.5t_{c(SPC)S} + 0.25t_{c(ICLK)}$ | 115      |
| 3(6)             | t <sub>w(SPCL)S</sub>           | Pulse duration, SPInCLK low (clock polarity = 0)                        | $0.5t_{c(SPC)S} - 0.25t_{c(ICLK)}$          | $0.5t_{c(SPC)S} + 0.25t_{c(ICLK)}$ | ns       |
| 3(0)             | t <sub>w(SPCH)S</sub>           | Pulse duration, SPInCLK high (clock polarity = 1)                       | $0.5t_{c(SPC)S} - 0.25t_{c(ICLK)}$          | $0.5t_{c(SPC)S} + 0.25t_{c(ICLK)}$ | 115      |
| 4(6)             | t <sub>v(SOMI-</sub><br>SPCH)S  | Valid time, SPInCLK high after SPInSOMI data valid (clock polarity = 0) | $0.5t_{c(\text{SPC})\text{S}}-6-t_{r}$      |                                    |          |
| 4(0)             | t <sub>v(SOMI-</sub><br>SPCL)S  | Valid time, SPInCLK low after SPInSOMI data valid (clock polarity = 1)  | $0.5t_{c(SPC)S}-6-t_{f}$                    |                                    | - ns     |
| 5(6)             | t <sub>v(SPCH</sub> -<br>SOMI)S | Valid time, SPInSOMI data valid after SPInCLK high (clock polarity = 0) | $0.5t_{c(SPC)S}-6-t_r$                      |                                    | -        |
| 5(-)             | t <sub>v(SPCL</sub> -<br>SOMI)S | Valid time, SPInSOMI data valid after SPInCLK low (clock polarity = 1)  | $0.5 t_{c(\text{SPC})\text{S}} - 6 - t_{f}$ |                                    | - ns     |
| 6 <sup>(6)</sup> | t <sub>su(SIMO-</sub><br>SPCH)S | Setup time, SPInSIMO before SPInCLK high (clock polarity = 0)           | 6   |                                    | 50       |
| 0(0)             | t <sub>su(SIMO-</sub><br>SPCL)S | Setup time, SPInSIMO before SPInCLK low (clock polarity = 1)            | 6   |                                    | ns       |
| 7(6)             | t <sub>v(SPCH</sub> -<br>SIMO)S | Valid time, SPInSIMO data valid after SPInCLK high (clock polarity = 0) | 6   |                                    |          |
| 1(0)             | t <sub>v(SPCL</sub> -<br>SIMO)S | Valid time, SPInSIMO data valid after SPInCLK low (clock polarity = 1)  | 6   |                                    | ns       |

(1) The MASTER bit (SPInCTRL2.3) is cleared and the CLOCK PHASE bit (SPInCTRL2[0]) is set.

(2) If the SPI is in slave mode, the following must be true:  $t_{c(SPC)S} \ge (PS + 1) t_{c(ICLK)}$ , where PS = prescale value set in SPInCTL1[12:5]. (3) For rise and fall timings, see the "Switching Characteristics for Output Timings versus Load Capacitance" table.

(4) t<sub>c(ICLK)</sub> = interface clock cycle time = 1/f<sub>(ICLK)</sub>
(5) When the SPIn is in slave mode, the following must be true: (b) When the of the balance index is the balance index in the balance index ind

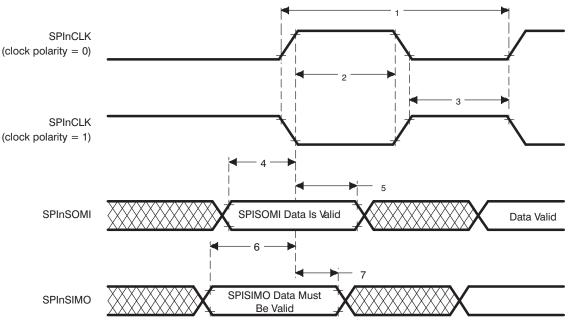


Figure 15. SPIn Slave Mode External Timing (CLOCK PHASE = 1)

### SCIn ISOSYNCHRONOUS MODE TIMINGS INTERNAL CLOCK

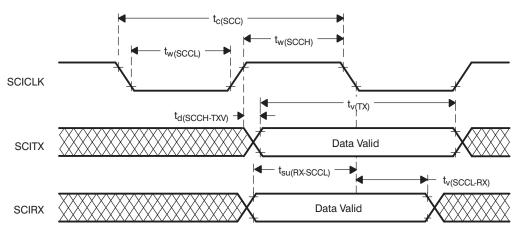
# Timing Requirements for Internal Clock SCIn Isosynchronous Mode<sup>(1)(2)(3)</sup>

(see Figure 16)

|                              |   | (BAUD + 1)<br>IS EVEN OR BAUD = 0 |                                      | (BAUD + 1)<br>IS ODD AND BAUD ≠ 0        |  |    |  |  |  | UNIT |
|------------------------------|---|-----------------------------------|--------------------------------------|--|--|----|--|--|--|------|
|                              |   | MIN                               | MAX                                  | MIN                                      | MAX  | -  |  |  |  |      |
| t <sub>c(SCC)</sub>          | Cycle time, SCInCLK                         | 2t <sub>c(ICLK)</sub>             | 2 <sup>24</sup> t <sub>c(ICLK)</sub> | 3t <sub>c(ICLK)</sub>                    | (2 <sup>24</sup> – 1) t <sub>c(ICLK)</sub> | ns |  |  |  |      |
| t <sub>w(SCCL)</sub>         | Pulse duration,<br>SCInCLK low              | $0.5t_{c(SCC)} - t_{f}$           | 0.5t <sub>c(SCC)</sub> + 5           | $0.5t_{c(SCC)} + 0.5t_{c(ICLK)} - t_{f}$ | $0.5t_{c(SCC)} + 0.5t_{c(ICLK)}$           | ns |  |  |  |      |
| t <sub>w(SCCH)</sub>         | Pulse duration,<br>SCInCLK high             | $0.5t_{c(SCC)} - t_{r}$           | 0.5t <sub>c(SCC)</sub> + 5           | $0.5t_{c(SCC)} - 0.5t_{c(ICLK)} - t_r$   | $0.5t_{c(SCC)} - 0.5t_{c(ICLK)}$           | ns |  |  |  |      |
| t <sub>d(SCCH-</sub><br>TXV) | Delay time, SCInCLK<br>high to SCInTX valid |                                   | 10                                   |  | 10   | ns |  |  |  |      |
| t <sub>v(TX)</sub>           | Valid time, SCInTX data after SCInCLK low   | $t_{c(SCC)} - 10$                 |                                      | $t_{c(SCC)} - 10$                        |  | ns |  |  |  |      |
| t <sub>su(RX-SCCL)</sub>     | Setup time, SCInRX before SCInCLK low       | $t_{c(ICLK)} + t_{f} + 20$        |                                      | $t_{c(ICLK)} + t_{f} + 20$               |  | ns |  |  |  |      |
| t <sub>v(SCCL-RX)</sub>      | Valid time, SCInRX data after SCInCLK low   | $-t_{c(ICLK)} + t_{f} + 20$       |                                      | $-t_{c(ICLK)} + t_{f} + 20$              |  | ns |  |  |  |      |

BAUD = 24-bit concatenated value formed by the SCI[H,M,L]BAUD registers. (1)

(2) t<sub>c(ICLK)</sub> = interface clock cycle time = 1/f<sub>(ICLK)</sub>
 (3) For rise and fall timings, see the "Switching Characteristics for Output Timings versus Load Capacitance" table



Data transmission/reception characteristics for isosynchronous mode with internal clocking are similar to the Α. asynchronous mode. Data transmission occurs on the SCICLK rising edge, and data reception occurs on the SCICLK falling edge.

#### Figure 16. SCIn Isosynchronous Mode Timing Diagram for Internal Clock

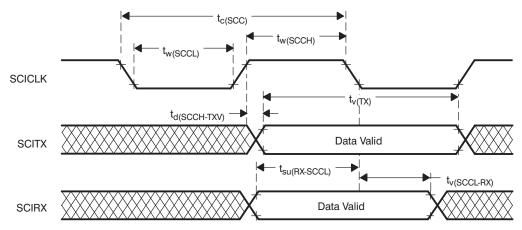
## SCIn ISOSYNCHRONOUS MODE TIMINGS EXTERNAL CLOCK

# Timing Requirements for External Clock SCIn Isosynchronous Mode<sup>(1)(2)</sup>

(see Figure 17)

|                          |   | MIN                               | MAX                               | UNIT |
|--------------------------|---|-----------------------------------|-----------------------------------|------|
| t <sub>c(SCC)</sub>      | Cycle time, SCInCLK <sup>(3)</sup>        | 8t <sub>c(ICLK)</sub>             |                                   | ns   |
| t <sub>w(SCCH)</sub>     | Pulse duration, SCInCLK high              | $0.5t_{c(SCC)} - 0.25t_{c(ICLK)}$ | $0.5t_{c(SCC)} + 0.25t_{c(ICLK)}$ | ns   |
| t <sub>w(SCCL)</sub>     | Pulse duration, SCInCLK low               | $0.5t_{c(SCC)} - 0.25t_{c(ICLK)}$ | $0.5t_{c(SCC)} + 0.25t_{c(ICLK)}$ | ns   |
| t <sub>d(SCCH-TXV)</sub> | Delay time, SCInCLK high to SCInTX valid  |                                   | $2t_{c(ICLK)} + 12 + t_r$         | ns   |
| t <sub>v(TX)</sub>       | Valid time, SCInTX data after SCInCLK low | 2t <sub>c(SCC)</sub> – 10         |                                   | ns   |
| t <sub>su(RX-SCCL)</sub> | Setup time, SCInRX before SCInCLK low     | 0                                 |                                   | ns   |
| t <sub>v(SCCL-RX)</sub>  | Valid time, SCInRX data after SCInCLK low | 2t <sub>c(ICLK)</sub> + 10        |                                   | ns   |

(1)  $t_{c(ICLK)} = interface clock cycle time = 1/f_{(ICLK)}$ (2) For rise and fall timings, see the "Switching Characteristics for Output Timings versus Load Capacitance" table. (3) When driving an external SCInCLK, the following must be true:  $t_{c(SCC)} \ge 8t_{c(ICLK)}$ 



Α. Data transmission / reception characteristics for isosynchronous mode with external clocking are similar to the asynchronous mode. Data transmission occurs on the SCICLK rising edge, and data reception occurs on the SCICLK falling edge.

#### Figure 17. SCIn Isosynchronous Mode Timing Diagram for External Clock



### **HIGH-END TIMER (HET) TIMINGS**

#### Minimum PWM Output Pulse Width:

This is equal to one high resolution clock period (HRP). The HRP is defined by the 6-bit high resolution prescale factor (hr), which is user defined, giving prescale factors of 1 to 64, with a linear increment of codes.

Therefore, the minimum PWM output pulse width = HRP(min) = hr(min)/SYSCLK = 1/SYSCLK

For example, for a SYSCLK of 30 MHz, the minimum PWM output pulse width = 1/30 = 33.33ns

#### Minimum Input Pulses that Can Be Captured:

The input pulse width must be greater or equal to the low resolution clock period (LRP), i.e., the HET loop (the HET program must fit within the LRP). The LRP is defined by the 3-bit loop-resolution prescale factor (Ir), which is user defined, with a power of 2 increment of codes. That is, the value of Ir can be 1, 2, 4, 8, 16, or 32.

Therefore, the minimum input pulse width = LRP(min) = hr(min) \* Ir(min)/SYSCLK = 1 \* 1/SYSCLK

For example, with a SYSCLK of 30 MHz, the minimum input pulse width = 1 \* 1/30 = 33.33 ns

#### NOTE:

Once the input pulse width is greater than LRP, the resolution of the measurement is still HRP. (That is, the captured value gives the number of HRP clocks inside the pulse.)

Abbreviations:

hr = HET high resolution divide rate = 1, 2, 3,...63, 64

Ir = HET low resolution divide rate = 1, 2, 4, 8, 16, 32

High resolution clock period = HRP = hr/SYSCLK

Loop resolution clock period = LRP = hr\*lr/SYSCLK

### STANDARD CAN CONTROLLER (SCC) MODE TIMINGS

#### **Dynamic Characteristics for the CANSTX and CANSRX Pins**

|                        | MIN  | MAX | UNIT |    |
|------------------------|--|-----|------|----|
| t <sub>d(CANSTX)</sub> |  | 15  | ns   |    |
| t <sub>d(CANSRX)</sub> | Delay time, CANSRX pin to receive shift register |     | 5    | ns |

(1) These values do not include rise/fall times of the output buffer.

### MULTI-BUFFERED A-TO-D CONVERTER (MibADC)

The multi-buffered A-to-D converter (MibADC) has a separate power bus for its analog circuitry. This power bus enhances the A-to-D performance by preventing digital switching noise on the logic circuitry that could be present on V<sub>SS</sub> and V<sub>CC</sub> from coupling into the A-to-D analog stage. All A-to-D specifications are given with respect to AD<sub>REFLO</sub> unless otherwise noted.

Resolution Monotonic

10 bits (1024 values)

Assured

Output conversion code

00h to 3FFh [00 for  $V_{AI} \le AD_{REFLO}$ ; 3FF for  $V_{AI} \ge AD_{REFHI}$ ]

### MibADC Recommended Operating Conditions<sup>(1)</sup>

|                     |   | MIN               | МАХ               | UNIT |
|---------------------|---|-------------------|-------------------|------|
| AD <sub>REFHI</sub> | A-to-D high-voltage reference source  | V <sub>SSAD</sub> | V <sub>CCAD</sub> | V    |
| AD <sub>REFLO</sub> | A-to-D low-voltage reference source   | V <sub>SSAD</sub> | V <sub>CCAD</sub> | V    |
| V <sub>AI</sub>     | Analog input voltage  | $V_{SSAD} - 0.3$  | $V_{CCAD}$ + 0.3  | V    |
| I <sub>AIC</sub>    | Analog input clamp current <sup>(2)</sup><br>( $V_{AI} < V_{SSAD} - 0.3$ or $V_{AI} > V_{CCAD} + 0.3$ ) | -2                | 2                 | mA   |

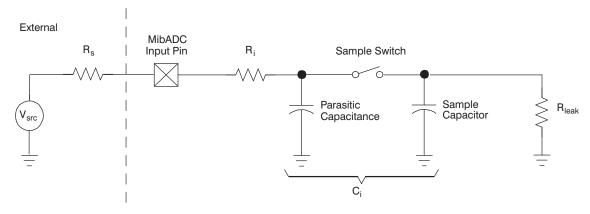
For V<sub>CCAD</sub> and V<sub>SSAD</sub> recommended operating conditions, see the "device recommended operating conditions" table. (1)

(2) Input currents into any ADC input channel outside the specified limits could affect conversion results of other channels.

#### Operating Characteristics over Full Ranges of Recommended Operating Conditions<sup>(1)(2)</sup>

|                      | PARAMETER  | DESCRIPTION/CONDITIONS   |            |  | TYP | MAX | UNIT |
|----------------------|--|--|------------|--|-----|-----|------|
| R <sub>I</sub>       | Analog input resistance                                      | See Figure 18.   |            |  | 250 | 500 | Ω    |
| CI                   |  | See Figure 18  | Conversion |  |     | 10  | pF   |
|                      | Analog input capacitance                                     | See Figure 18.   | Sampling   |  |     | 30  | pF   |
| I <sub>AIL</sub>     | Analog input leakage current                                 | See Figure 18.   |            |  |     | 1   | μA   |
| I <sub>ADREFHI</sub> | AD <sub>REFHI</sub> input current                            | $AD_{REFHI} = 3.6 V, AD_{REFLO} = V_{SSAD}$  |            |  |     | 5   | mA   |
| CR                   | Conversion range over which specified accuracy is maintained | AD <sub>REFHI</sub> - AD <sub>REFLO</sub>  | 3          |  | 3.6 | V   |      |
| E <sub>DNL</sub>     | Differential nonlinearity error                              | Difference between the actual step widtl value after offset correction. See Figure   |            |  | ±2  | LSB |      |
| E <sub>INL</sub>     | Integral nonlinearity error                                  | Maximum deviation from the best straight line through<br>the MibADC. MibADC transfer characteristics,<br>excluding the quantization error after offset correction.<br>See Figure 20. |            |  |     | ±2  | LSB  |
| E <sub>TOT</sub>     | Total error/Absolute accuracy                                | Maximum value of the difference betwee value and the ideal midstep value. See  |            |  | ±2  | LSB |      |

(1)  $V_{CCAD} = AD_{REFHI}$ (2) 1 LSB =  $(AD_{REFHI} - AD_{REFLO})/2^{10}$  for the MibADC



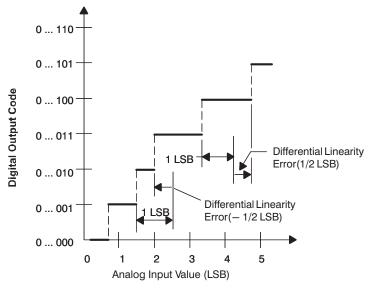
#### Figure 18. MibADC Input Equivalent Circuit

#### Multi-Buffer ADC Timing Requirements

|                                    |   | MIN MA | X UNIT |
|------------------------------------|---|--------|--------|
| t <sub>c(ADCLK)</sub>              | Cycle time, MibADC clock                          | 0.05   | μs     |
| t <sub>d(SH)</sub>                 | Delay time, sample and hold time                  | 1      | μs     |
| t <sub>d©)</sub>                   | Delay time, conversion time                       | 0.55   | μs     |
| t <sub>d(SHC)</sub> <sup>(1)</sup> | Delay time, total sample/hold and conversion time | 1.55   | μs     |

(1) This is the minimum sample/hold and conversion time that can be achieved. These parameters are dependent on many factors; for more details, see the TMS470R1x Multi-Buffered Analog-to-Digital Converter (MibADC) Reference Guide (literature number SPNU206).

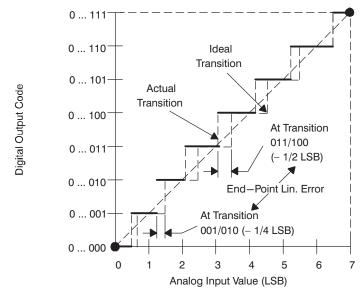
The differential nonlinearity error shown in Figure 19 (sometimes referred to as differential linearity) is the difference between an actual step width and the ideal value of 1 LSB.



A. 1 LSB =  $(AD_{REFHI} - AD_{REFLO})/2^{10}$ 

Figure 19. Differential Nonlinearity (DNL)

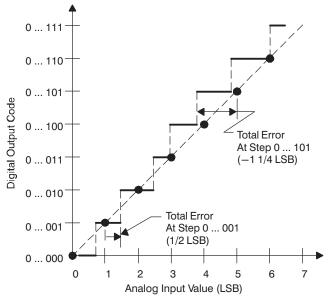
The integral nonlinearity error shown in Figure 20 (sometimes referred to as linearity error) is the deviation of the values on the actual transfer function from a straight line.



A. 1 LSB =  $(AD_{REFHI} - AD_{REFLO})/2^{10}$ 

Figure 20. Integral Nonlinearity (INL) Error

The absolute accuracy or total error of an MibADC as shown in Figure 21 is the maximum value of the difference between an analog value and the ideal midstep value.



A. 1 LSB =  $(AD_{REFHI} - AD_{REFLO})/2^{10}$ 

Figure 21. Absolute Accuracy (Total) Error

### THERMAL CHARACTERISTICS

| PARAMETER        | °C/W |
|------------------|------|
| R <sub>θJA</sub> | 48   |
| R <sub>θJC</sub> | 5    |



### **REVISION HISTORY**

This revision history highlights the changes made to the device-specific datasheet SPNS099 to create the SPNS099A version.

#### **Table 9. Revision History**

#### SPNS099A to SPNS099B

Revised the Family Nomenclature drawing, Figure 2, to add Q version of the temperature range.

Revised "Absolute Maximum Ratings" table to add Q version of the temperature range.

Revised "Device Recommended Operating Conditions" table to add Q version of the temperature range.

Added note to PORRST Timing Diagram.

Changed  $T_A$  range to -40°C to 125°C on  $t_{wec}$  in "Timing Requirements for Program Flash" table.

Added twee MIN value of 50000 and deleted MAX value in "Timing Requirements for Program Flash" table.

Changed terase(sector) TYP value to 1.7 and removed MAX value in "Timing Requirements for Program Flash" table.

#### SPNS099 to SPNS099A

In "Memory Selects" section, added decoded block size = 0x00100000.

Moved "XOR Share" section to "Description" section.

In "Flash Program and Erase" section, added information about executing from different banks and note about OTP sector.

Updated temperature range to T version, -40°C to 105°C, throughout.

Updated device identification code register value in "Device Identification Code Register."

Added "Device and Development-Support Tool Nomenclature" information.

Changed V<sub>CC</sub> to 2.06 V from 2.05 V throughout.

Separate  $V_{IL}$  and  $V_{IH}$  values added for OSCIN in the "Electrical Characteristics over Recommended Operating Free-Air Temperature Range" table.

I<sub>CC</sub> value at SYSCLK - 24 MHZ deleted in the "Electrical Characteristics over Recommended Operating Free-Air Temperature Range" table.

Removed "all frequencies" from halt test conditions, I<sub>CC</sub>, in the "Electrical Characteristics over Recommended Operating Free-Air Temperature Range" table.

Operating I<sub>CC</sub> value (pipeline mode) changed to 70 mA in the "Electrical Characteristics over Recommended Operating Free-Air Temperature Range" table.

I<sub>CCp</sub> read operation value changed to 50 mA in the "Electrical Characteristics over Recommended Operating Free-Air Temperature Range" table.

f<sub>(OSCRST)</sub> value changed from MAX to TYP in "Timing Requirements for ZPLL Circuits Enabled or Disabled" table.

Moved 2.75 from Max to Min column for V<sub>CCIOPORH</sub> in "Timing Requirements for PORRST" table.

Added row for T<sub>fsu</sub> to "Switching Characteristics over Recommended Operating Conditions for RST" table.

Updated t<sub>prog(Total)</sub> to 0.5 s typical and 2 s maximum.

Added rows for  $T_{fp(RST)}$ ,  $T_{fp(SLEEP)}$ , and  $T_{fp(STANDBY)}$  to "Flash Timings" table.



10-Dec-2020

## PACKAGING INFORMATION

| Orderable Device | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2) | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|---------|
| TMS470R1A64PNT   | NRND          | LQFP         | PN                 | 80   | 119            | RoHS & Green    | NIPDAU                               | Level-3-260C-168 HR  |              | 470R1A64PNT<br>TMS      |         |

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

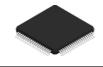
<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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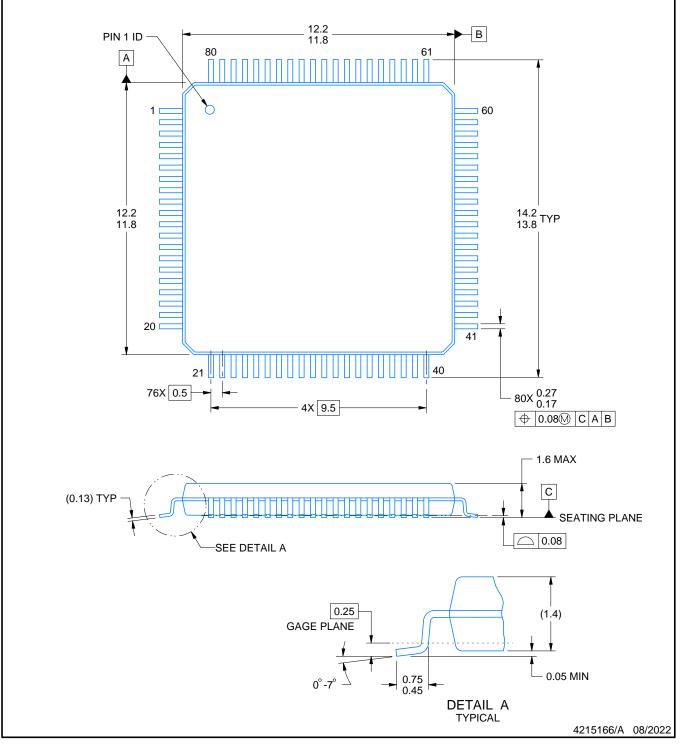
# **PN0080A**



# **PACKAGE OUTLINE**

# LQFP - 1.6 mm max height

PLASTIC QUAD FLATPACK



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing All lifear differsions are in minimeters, vary amore per ASME Y14.5M.
   This drawing is subject to change without notice.
   Reference JEDEC registration MS-026.

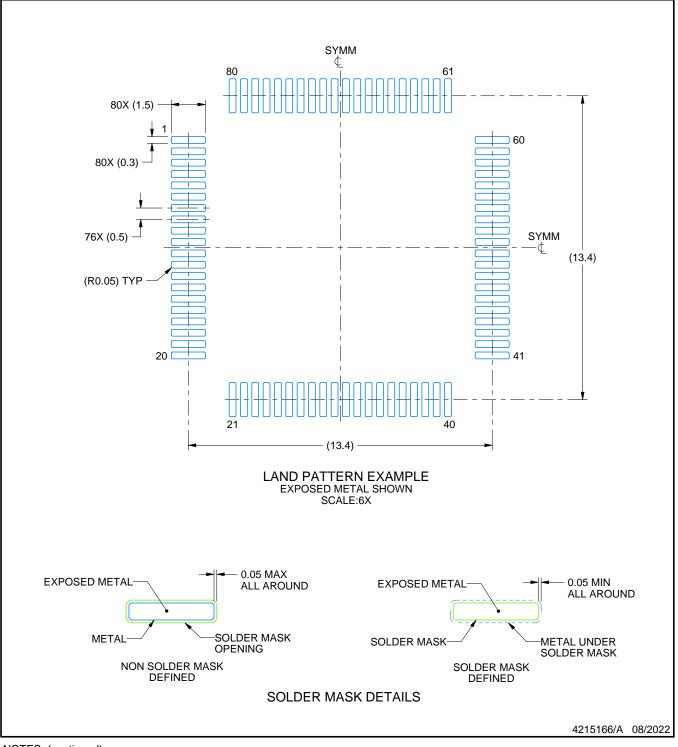


# **PN0080A**

# **EXAMPLE BOARD LAYOUT**

## LQFP - 1.6 mm max height

PLASTIC QUAD FLATPACK



NOTES: (continued)

4. Publication IPC-7351 may have alternate designs.

Solder mask tolerances between and around signal pads can vary based on board fabrication site.
 For more information, see Texas Instruments literature number SLMA004 (www.ti.com/lit/slma004).

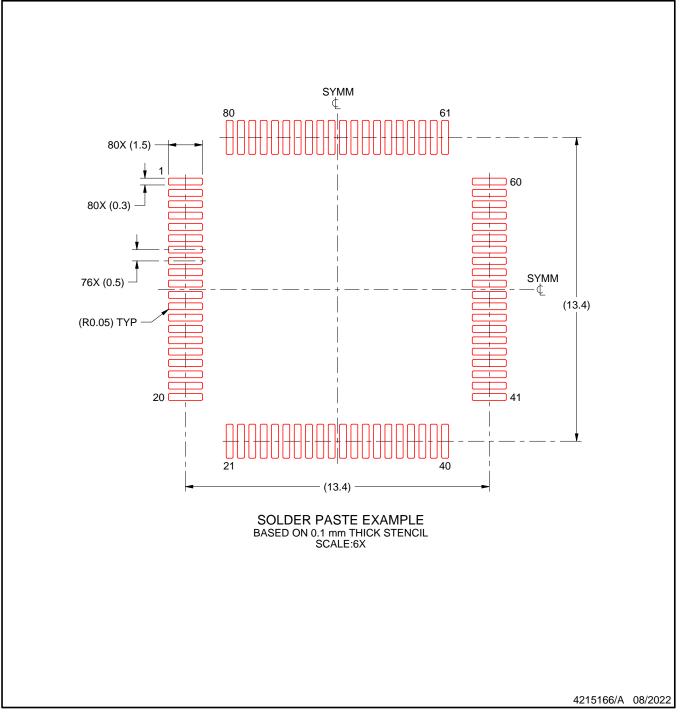


# PN0080A

# **EXAMPLE STENCIL DESIGN**

## LQFP - 1.6 mm max height

PLASTIC QUAD FLATPACK



NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

8. Board assembly site may have different recommendations for stencil design.



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